

# Optoelectronică

Curs 11  
2023/2024

# Disciplina 2023/2024

- ▶ 2C/1L Optoelectronică **OPTO**
- ▶ **Minim 7 prezente curs + laborator**
- ▶ Curs – conf. **Radu Damian**
  - an IV  $\mu$ E
  - Marti 14(**:10**)-16:00, P8
  - E – 70% din nota (50%+20%)
    - **20% test (VP) la curs**, saptamana 4-6?
  - probleme + (2p prez. curs)
  - toate materialele permise
- ▶ Laborator – **drd. Stefan Stoica**
  - an IV  $\mu$ E
    - Marti 16-20 par
    - Max. 7 prezente
  - L – 30% din nota (+Caiet de laborator)

# Cuprins

- ▶ **Lumina ca undă electromagnetică\*** (ecuațiile lui Maxwell, ecuația undelor, parametri de propagare)
- ▶ **Elemente de fotometrie și radiometrie\*** (mărimi energetice/luminoase)
- ▶ **Fibra optică** (realizare, principiu de funcționare, atenuare, dispersie, banda de frecvență)
- ▶ **Cabluri optice** (tehnologie, conectori, lipire – splice)
- ▶ **Proiectare sistemică a legăturii pe fibra optică** (bandă de frecvență, balanța puterilor)
- ▶ **Emitătoare optice** (LED și dioda laser – realizare fizică și funcționare)
- ▶ **Receptoare optice** (dioda PIN, dioda cu avalanșă – realizare fizică și funcționare)
- ▶ **Amplificatoare transimpedanță** (parametri, scheme tipice, TIA în buclă deschisă, cu reacție, diferențiale, control automat al câștigului)
- ▶ **Realizarea circuitelor pentru controlul emițătoarelor optice** (parametri, scheme tipice, controlul puterii, multiplexoare)
- ▶ **Dispozitive de captare a energiei solare** (principiu de funcționare, utilizare, proiectare )

\* – VP

# Documentatie



English | Romana |

[Main](#) [Courses](#) [Master](#) [Staff](#) [Research](#) [Students](#)

## Microwave and Optoelectronics Laboratory

We are enlisted in the Telecommunications Department of the Electronics, Telecommunication and Information Technology Faculty (ETIT) from the "Gh. Asachi" Technical University (TUIASI) in Iasi, Romania

We currently cover inside ETIT the fields related to:

- Microwave Circuits and Devices
- Optoelectronics
- Information Technology

### Courses

Nr.	Course	Shortcut	Code	Type	Semester	Credits	Weekly	Examination	Link
1	Microwave Devices and Circuits for Radiocommunications	DCMR	DOS412T	DOS	7	4	0P,1L,0S,2C	Exam	<a href="#">details</a>
2	Monolithic Microwave Integrated Circuits	CIMM	RD.IA.207	DOMS	11	6	1.5L,0S,2C,0P	Exam	<a href="#">details</a>
3	Advanced Techniques in the Design of the Radio-communications Systems	TAPSR	RD.IA.103	DIMS	9	6	1.5P,0L,0S,2C	Exam	<a href="#">details</a>
4	Optical Communications	CO	DOS409T	DOS	7	5	0P,1L,0S,3C	Colloquium	<a href="#">details</a>
5	Optical Communications	OC	EDOS409T	DOS	7	5	0P,1L,0S,3C	Exam	<a href="#">details</a>
6	Satellite Communications	CS	RC.IA.104	DIMS	9	6	0L,0S,2C,1.5P	Exam	<a href="#">details</a>
7	Applied Informatics 1	IA1	DOF135	DOF	1	4	0P,1L,0S,2C	Verification	<a href="#">details</a>
8	Applied Informatics 1	AI1	EDOF135	DOF	1	4	0P,1L,0S,2C	Verification	<a href="#">details</a>
9	Databases, Web Programming and Interfacing	DWPI	ITT.IA.601	DIS	11	5	1P,1L,0.25S,1C	Verification	<a href="#">details</a>
10	Web Applications Design	PAW	RC.IA.108	DIMS	10	5	1L,0S,1.5C,1P	Exam	<a href="#">details</a>
11	Optoelectronics	OPTO	DID405M	DID	8	4	0P,1L,0S,2C	Colloquium	<a href="#">details</a>
12	Microwave Devices and Circuits for Radiocommunications (English)	MDCR	EDOS412T	DOS	8	4	0P,1L,0S,2C	Exam	<a href="#">details</a>



# Documentatie

- ▶ RF-OPTO
  - <http://rf-opto.etti.tuiasi.ro>
- ▶ Fotografie
  - “examen” online
  - necesara la laborator/curs

# LED

Dioda electroluminescenta

Capitolul 7

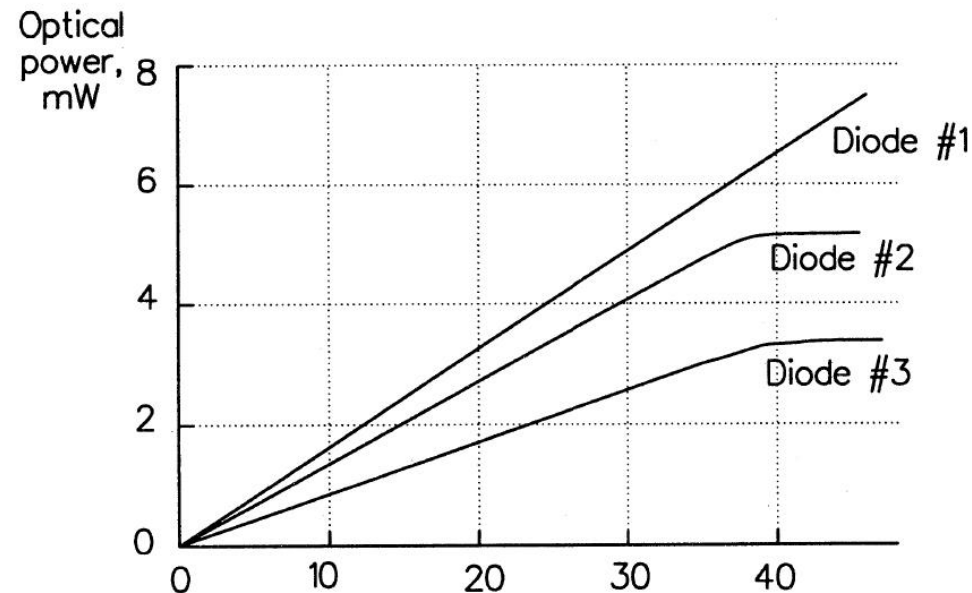
# Caracteristica de raspuns a LED-urilor

- ▶ Caracteristica putere optica emisa functie de curentul direct prin LED este liniara la nivele mici ale curentului.
- ▶ Nu exista curent de prag
- ▶ La nivele foarte mari puterea optica se satureaza

- ▶ Responzivitatea

$$r = \frac{P_o}{I} \left[ \frac{W}{A} \right]$$

- ▶ Tipic  $r = 50 \mu\text{W}/\text{mA}$



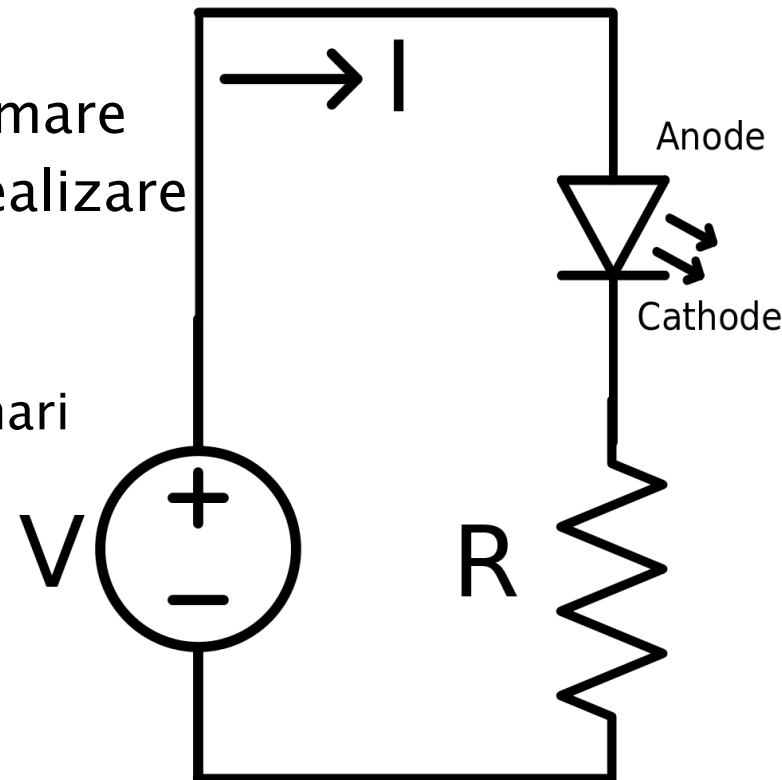
# Control static LED

## ▶ Cea mai simpla schema de control: un rezistor in serie cu LED

- **Atentie!** Tensiunea directa poate varia semnificativ ( $\gg 0.7V$ ) si trebuie preluata din catalog
  - mai ales la intensitate luminoasa mare
  - datorita materialelor diferite de realizare a LED-urilor
  - dependenta de lungimea de unda
    - mai mica la lungimi de unda mai mari

$$I_v = f(I_F [\text{mA}]) \quad [\text{cd/mcd}]$$

$$I_F = \frac{V_{cc} - V_F}{R}$$





# Control static LED



## Ultra Bright LED Lamps Round Types

Package	Part No.	Chip			Absolute Maximum Ratings				Electro-optical Data(At 20mA)			Viewing Angle 2θ 1/2 (deg)	Drawing No.
		Material Emitted Color	Peak Wave Length p(nm)	Dominant Wave Length λd(nm)	Δλ (nm)	Pd (mw)	If (mA)	Peak (mA)	Vf (V) Typ. Max	Iv (mcd) Typ.			
T-1 Standard 1.0" Lead 3φ Water Clear	BL-BF43V1	GaAlAs/ DDH Super Red	660	643 ± 5	20	80	30	150	2.0	2.6	700	25	L-001
	BL-BG33V1	InGaAlP/ Yellow Green	573	571 ± 5	15	100	30	150	2.2	2.6	700	25	
	BL-BG43V1	InGaN/SiC/ Bluish Green	505	505 ± 5	30	120	30	150	3.5	4.0	3500	24	
	BL-BG63V1	InGaN/SiC/ Green	525	525 ± 5	35	120	30	150	3.5	4.0	4000	24	
	BL-BJ23V1	InGaAlP/ Super Orange	620	615 ± 5	17	100	30	150	2.2	2.6	1700	25	
	BL-BJ33V1	InGaAlP/ Super Orange	630	625 ± 5	17	100	30	150	2.2	2.6	1100	25	
	BL-BJ63V1	InGaAlP/ Super Orange	610	605 ± 5	17	100	30	150	2.2	2.6	1500	25	
	BL-BJ73V1	InGaAlP/ Super Orange	630	625 ± 5	17	100	30	150	2.2	2.6	1500	25	
	BL-BJH3V1	InGaAlP/ Super Orange	630	625 ± 5	17	100	30	150	2.2	2.6	2500	25	
	BL-BJG3V1	InGaAlP/ Super Orange	630	625 ± 5	17	100	30	150	2.2	2.6	3000	25	
	BL-BK43V1	InGaAlP/ Super Yellow	590	587 ± 5	15	100	30	150	2.2	2.6	1600	25	
	BL-BK53V1	InGaAlP/ Super Yellow	595	594 ± 5	15	100	30	150	2.2	2.6	1500	25	
	BL-BK73V1	InGaAlP/ Super Yellow	595	594 ± 5	15	100	30	150	2.2	2.6	2000	25	
	BL-BK83V1	InGaAlP/ Super Yellow	590	587 ± 5	15	100	30	150	2.2	2.6	2000	25	
	BL-BKH3V1	InGaAlP/ Super Yellow	590	587 ± 5	15	100	30	150	2.2	2.6	2500	25	
	BL-BKG3V1	InGaAlP/ Super Yellow	590	587 ± 5	15	100	30	150	2.2	2.6	3000	25	
BL-BF43V4V	GaAlAs/ DDH Super Red	660	643 ± 5	20	80	30	150	2.0	2.6	1200	15		
BL-BG33V4V	InGaAlP/ Yellow Green	573	571 ± 5	15	100	30	150	2.2	2.6	1100	15		
BL-BG43V4V	InGaN/SiC/ Bluish Green	505	505 ± 5	30	120	30	150	3.5	4.0	6000	24		
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3.5	4.0	3500
3.5	4.0	4000
2.2	2.6	1700
2.2	2.6	1100

### ◆ Electro-Optical Characteristics

Item	Symbol	Condition	Minimum	Typical	Maximum	Unit
Forward Voltage	V <sub>F</sub>	I <sub>F</sub> = 240 mA		19.0		V
Brightness	I <sub>v</sub>	I <sub>F</sub> = 240 mA		13		cd
Total Radiated Power	P <sub>o</sub>	I <sub>F</sub> = 240 mA		60		mW

# Dioda Laser

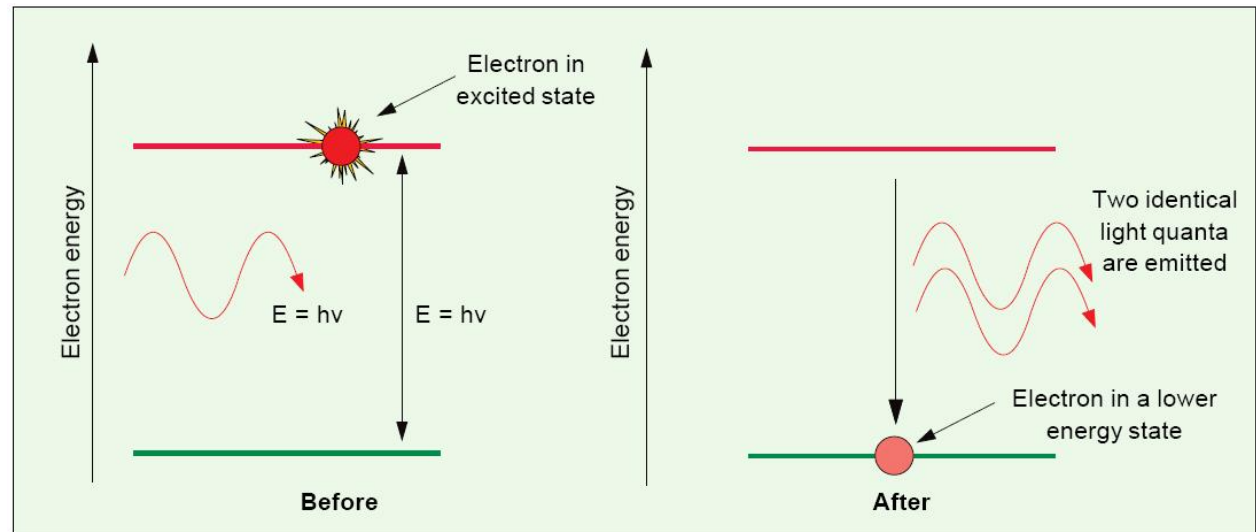
Capitolul 8

# Cuprins

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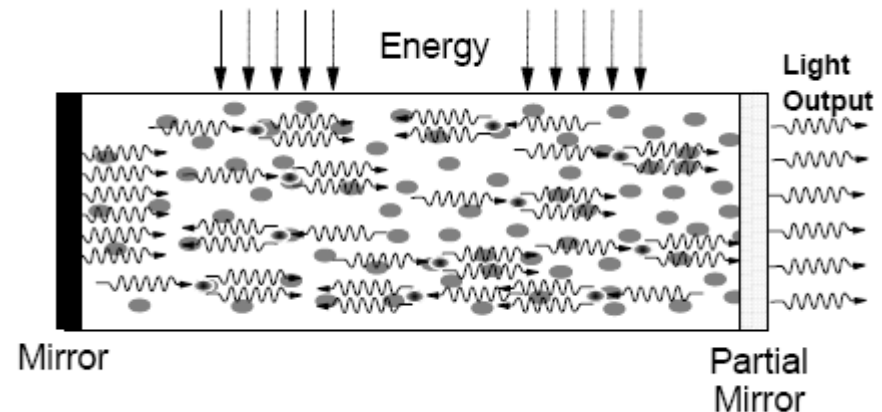
# Dioda LASER – Principiu de operare

- ▶ Emisia stimulata – un foton incident cu energie corespunzatoare poate stimula emisia unui al doilea foton **fara a fi absorbit**
- ▶ Noul foton are aceeasi directie si faza cu fotonul incident, Lumina rezultata e coerenta

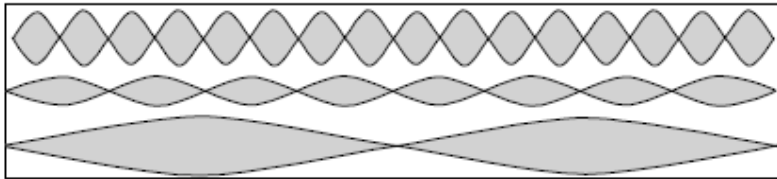


# Dioda LASER – Principiu de realizare

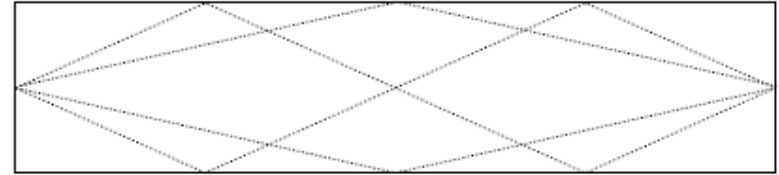
- ▶ Pentru ca emisia stimulata sa apara, fotonii emisi trebuie sa ramana in contact cu materialul o perioada mai mare de timp – 2 oglinzi necesare
- ▶ Pentru a permite extragerea radiatiei e necesar ca una din oglinzi sa fie partial reflectanta



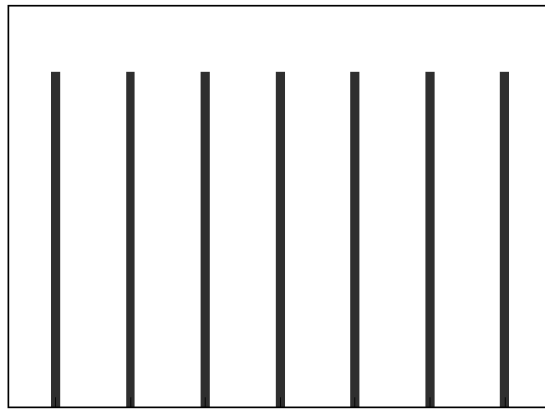
# Spectrul diodei LASER



Longitudinal Modes



Lateral Modes



1.490 1.494 1.497 1.5 1.503 1.507 1.510  
Wavelength (nm)

$$f_k = k \cdot \frac{c_0}{2 \cdot n \cdot L} \quad \Delta f = \frac{c_0}{2 \cdot n \cdot L}$$

$$\Delta \lambda \cong \frac{\lambda_0^2}{2 \cdot n \cdot L}$$

# Caracteristica de raspuns DL

- ▶ Amorsarea emisiei stimulate necesita pomparea unei anumite cantitati de energie - curent de prag

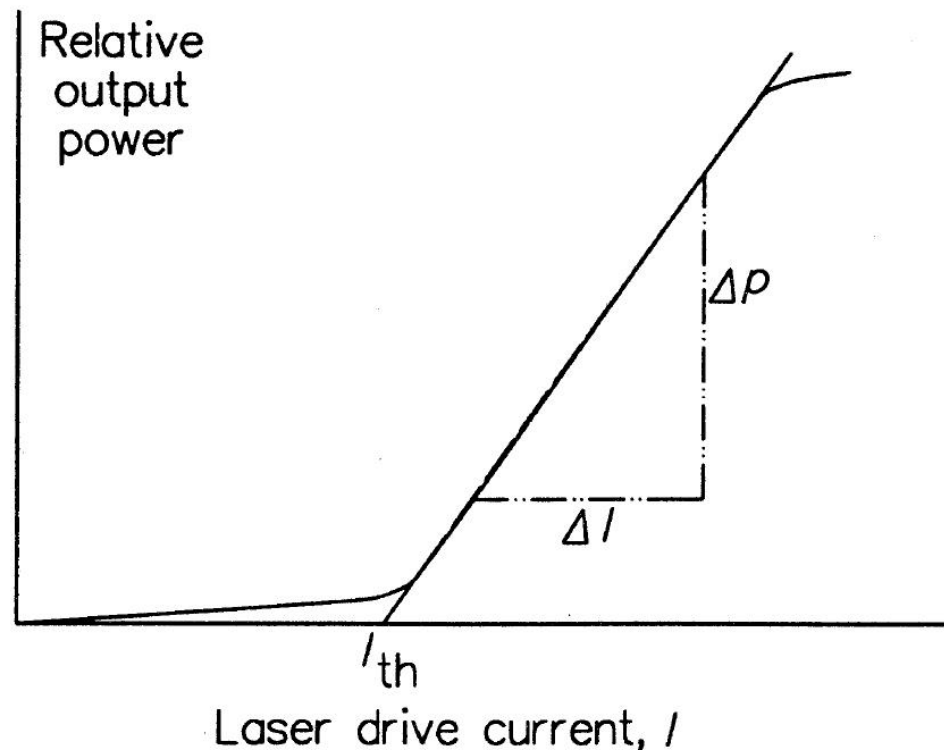
$I < I_{th}$  regim LED  
ineficient!,  $P_o \cong 0$

$I > I_{th}$  regim LASER

$$r = \frac{\Delta P_o}{\Delta I} \left[ \frac{W}{A} \right]$$

$$P_o = r \cdot (I - I_{th})$$

Apare saturare la nivele mari de curent

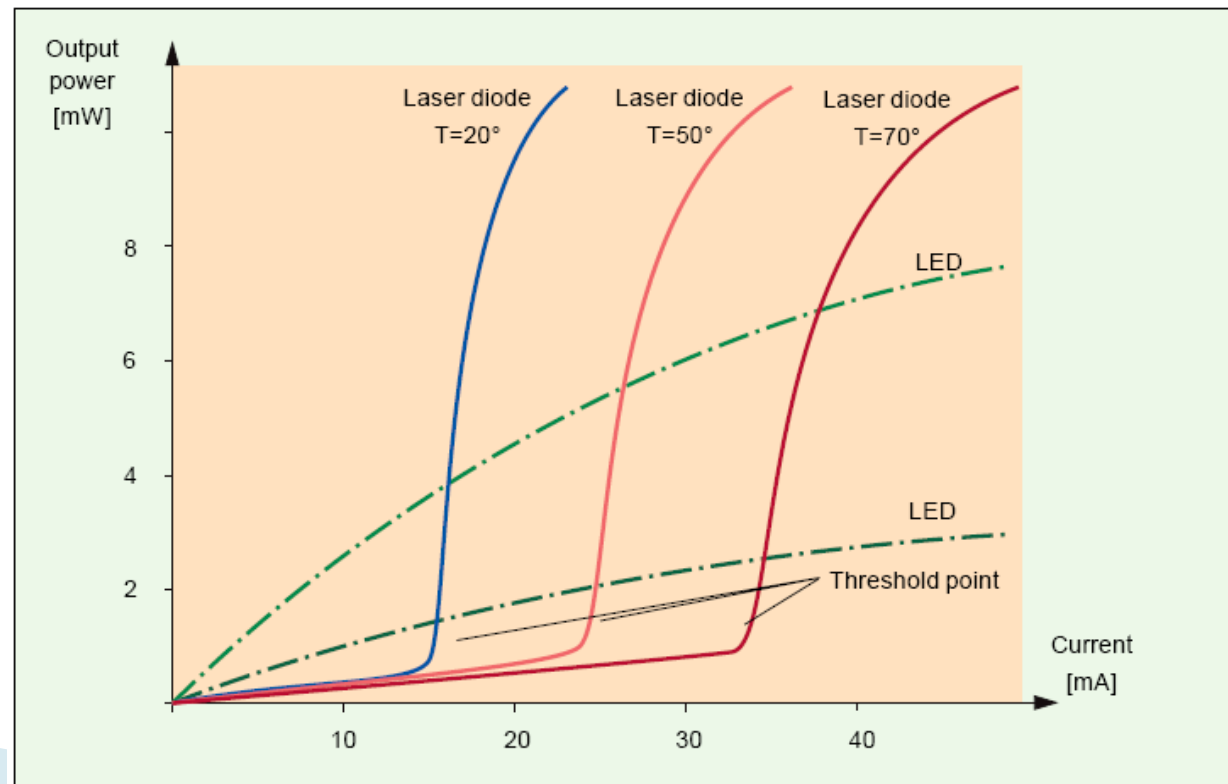


# Parametri dioda LASER



# Temperatura si îmbatrânire

- ▶ Curentul de prag variaza cu temperatura si cu timpul
- ▶ Variatia tipica 1–2%/°C



# Dependenta de temperatura

- ▶ Dependenta de temperatura a curentului de prag este exponentiala

$$I_{th} = I_0 \cdot e^{T/T_0}$$

- ▶  $I_0$  e o constanta determinata la temperatura de referinta

Material	Lungime de unda	$T_0$
InGaAsP	1300 nm	60÷70 K
InGaAsP	1500 nm	50÷70 K
GaAlAs	850 nm	110÷140 K

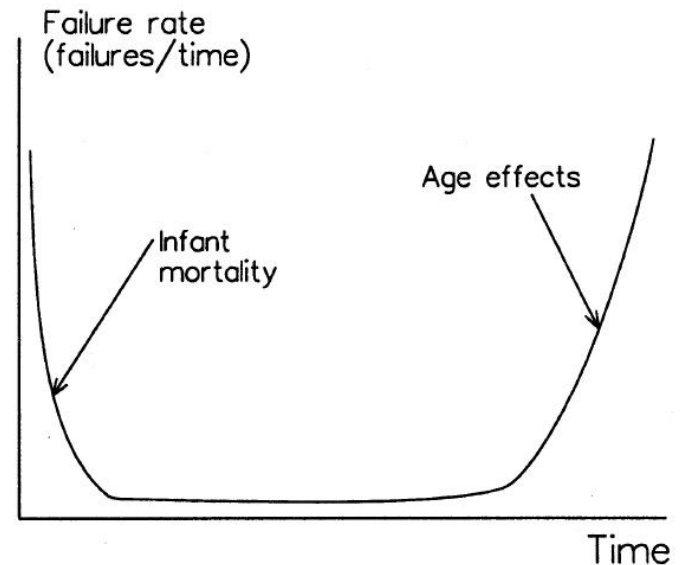
# Degradare in timp

- ▶ Puterea scade in timp exponential

$$P(t) = P_0 \cdot e^{-t/\tau_m}$$

- ▶  $\tau_m$  – timpul de viata
- ▶ Diodele laser sunt supuse la conditii extreme de lucru
  - densitati de curent in zona activa  $2000 \div 5000 \text{ A/cm}^2$
  - densitati de putere optica:  $10^5 \div 10^6 \text{ W/cm}^2$
- ▶ Diverse definitii ale timpului de viata fac comparatiile dificile

# Degradare in timp



- ▶ Cresterea curentului duce la scaderea duratei de viata

$$\tau_m \sim J^{-n}$$

- $n = 1.5 \div 2$  (empiric)
- dublarea curentului duce la scaderea de 3-4 ori a duratei de viata
- ▶ Cresterea temperaturii duce la scaderea duratei de viata

$$\tau_m \sim e^{E/kT}$$

- $E = 0.3 \div 0.95 \text{ eV}$  (valoarea tipica in teste 0.7eV)
- cresterea temperaturii cu 10 grade injumatateste durata de viata

# Parametri

- ▶ Coerenta radiatiei emise
  - LED:  $t_c \approx 0.5\text{ps}$ ,  $L_c \approx 15\mu\text{m}$
  - LASER :  $t_c \approx 0.5\text{ns}$ ,  $L_c \approx 15\text{cm}$

$$L_c = c \cdot t_c = \frac{\lambda_0^2}{\Delta\lambda}$$

- ▶ Stabilitatea frecventei
  - detectie necoerenta (modulatie in amplitudine)
  - mai ales in sistemele multicanal
- ▶ Timpul de raspuns
- ▶ Viteza, interval de reglaj

# Eficienta

- ▶ eficienta de conversie electro-optic (randament)

$$\eta = \frac{P_{out}(optic)}{P_{in}(electric)} = \frac{P_o}{V_f \cdot I_f} \approx \frac{r \cdot (I_f - I_{th})}{V_f \cdot I_f}$$

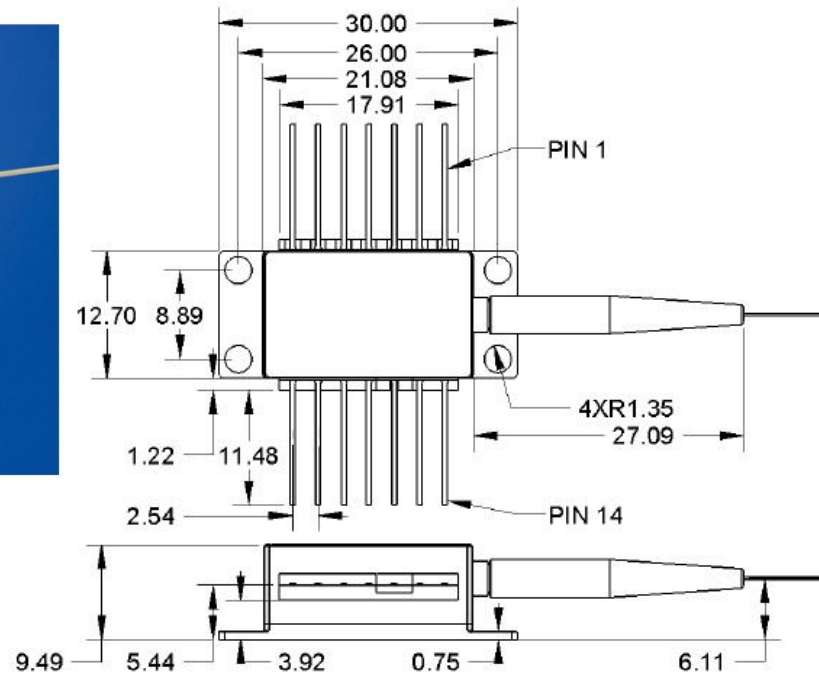
- ▶ tipic, randamente sub 10% sunt intalnite
- ▶ eficienta cuantica
  - interna
  - externa

$$\eta = \frac{n_f}{n_e} \quad \eta = \frac{\Delta P / h\nu}{\Delta I / e} = r \cdot \frac{e}{h\nu}$$

# 1550nm DFB Laser

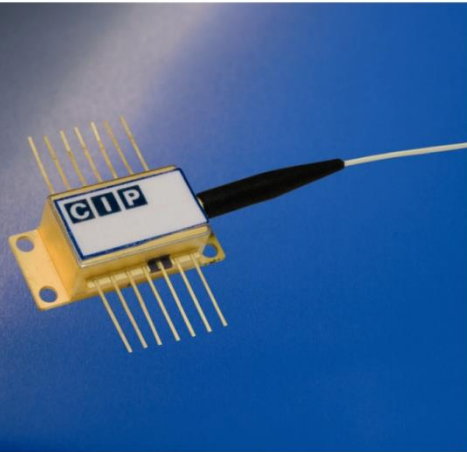
## Mechanical Drawing

All units in mm

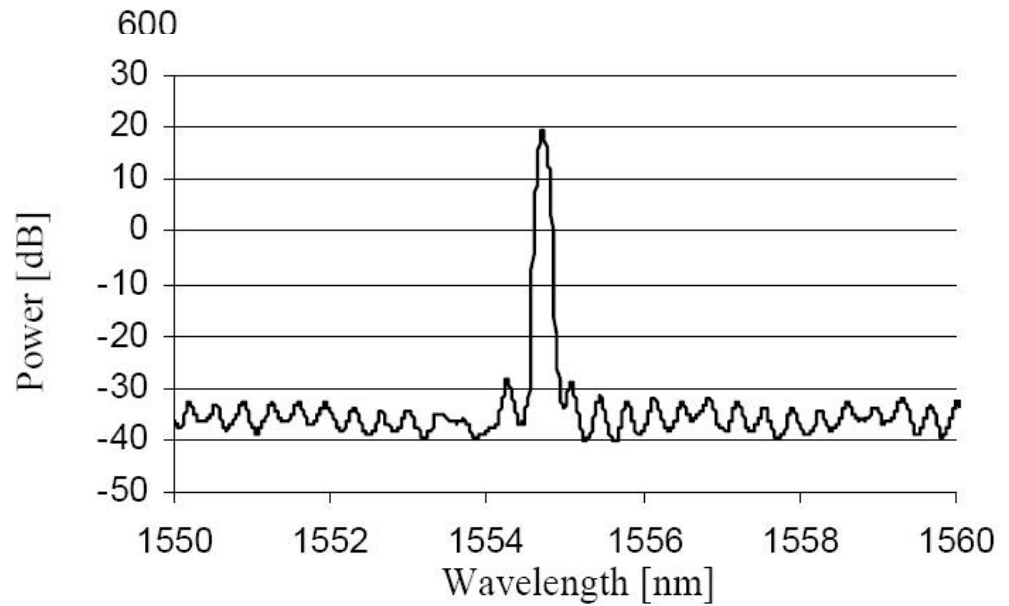
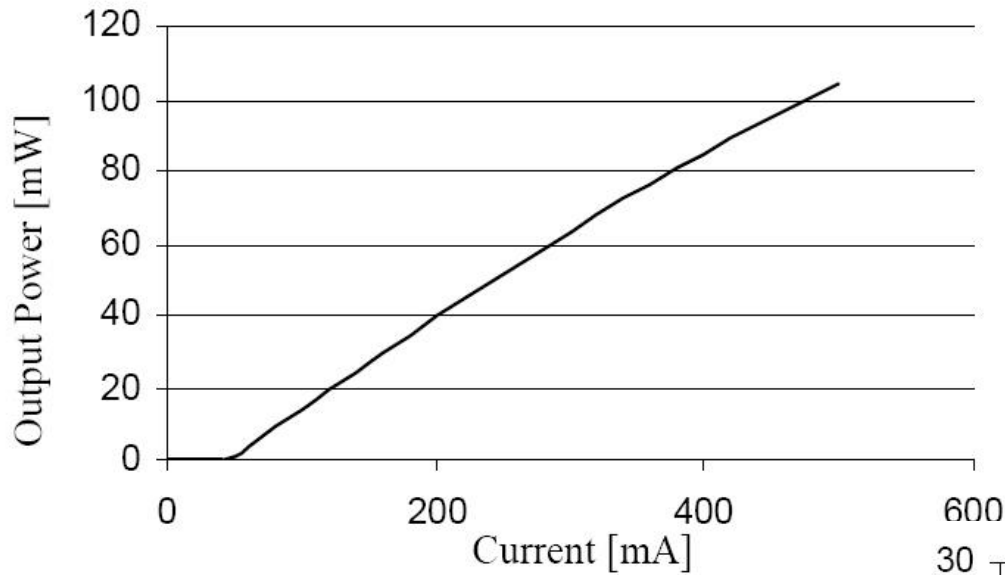


## Pin out

Pin	Description
1	Thermistor
2	Thermistor
3	Laser Cathode (Bias)
4	Monitor PD Anode
5	Monitor PD Cathode
6	TEC +
7	TEC -
8	Case GND, Laser Anode
9	Case GND, Laser Anode
10	Case GND, Laser Anode
11	Case GND, Laser Anode
12	Laser Cathode (modulation)
13	Case GND, Laser Anode
14	Case GND, Laser Anode

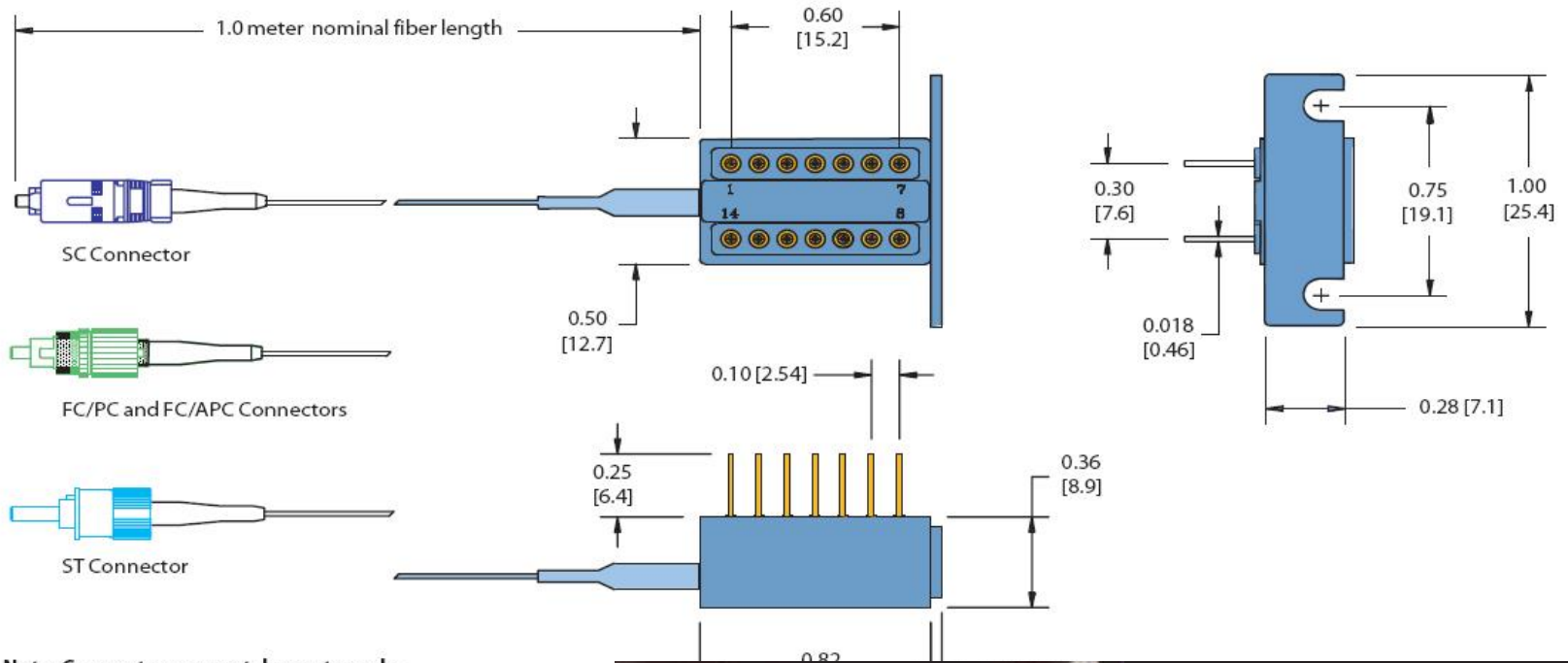


# 1550nm DFB Laser

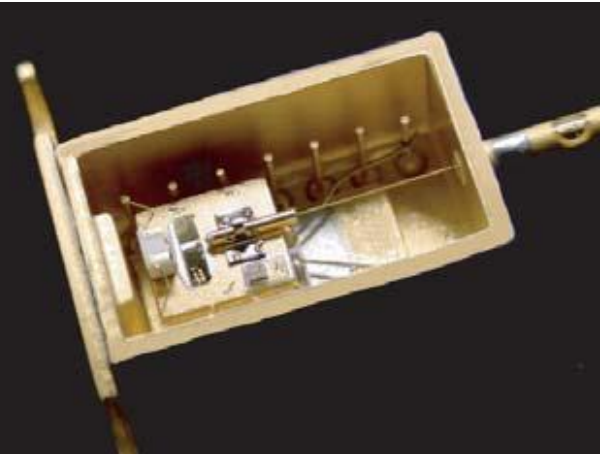
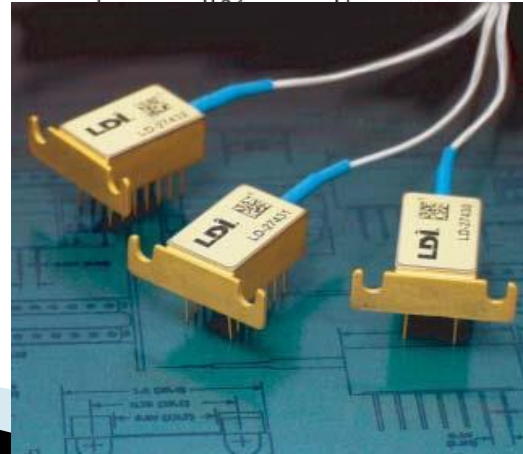




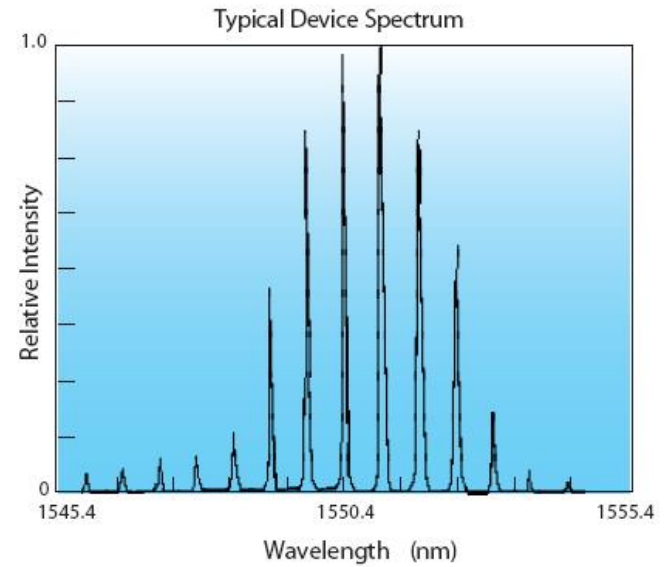
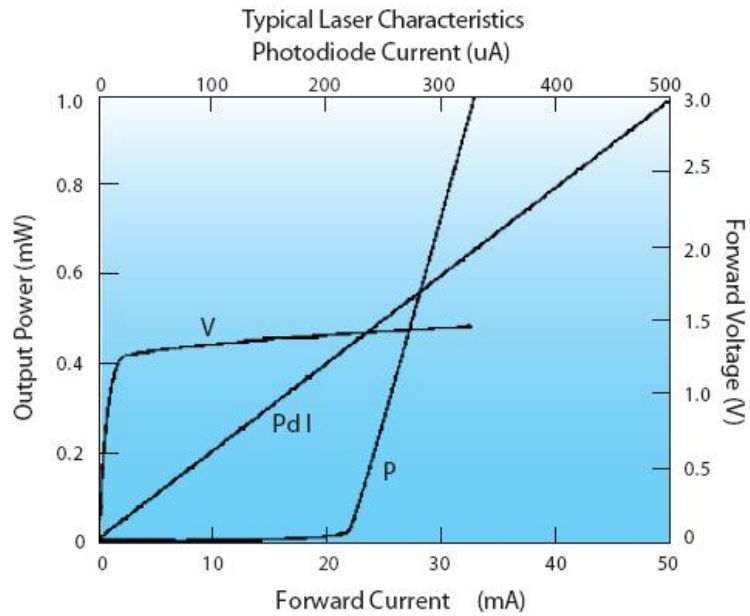
# 1550nm MQW Laser



Note: Connectors are not drawn to scale.

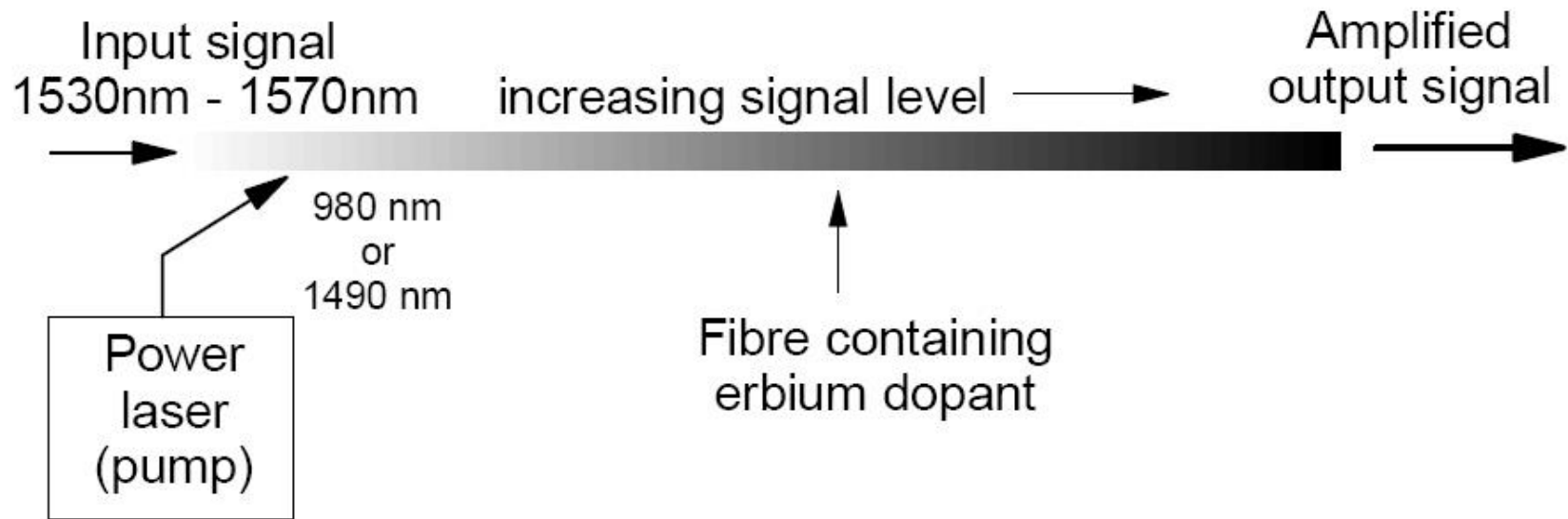


# 1550nm MQW Laser

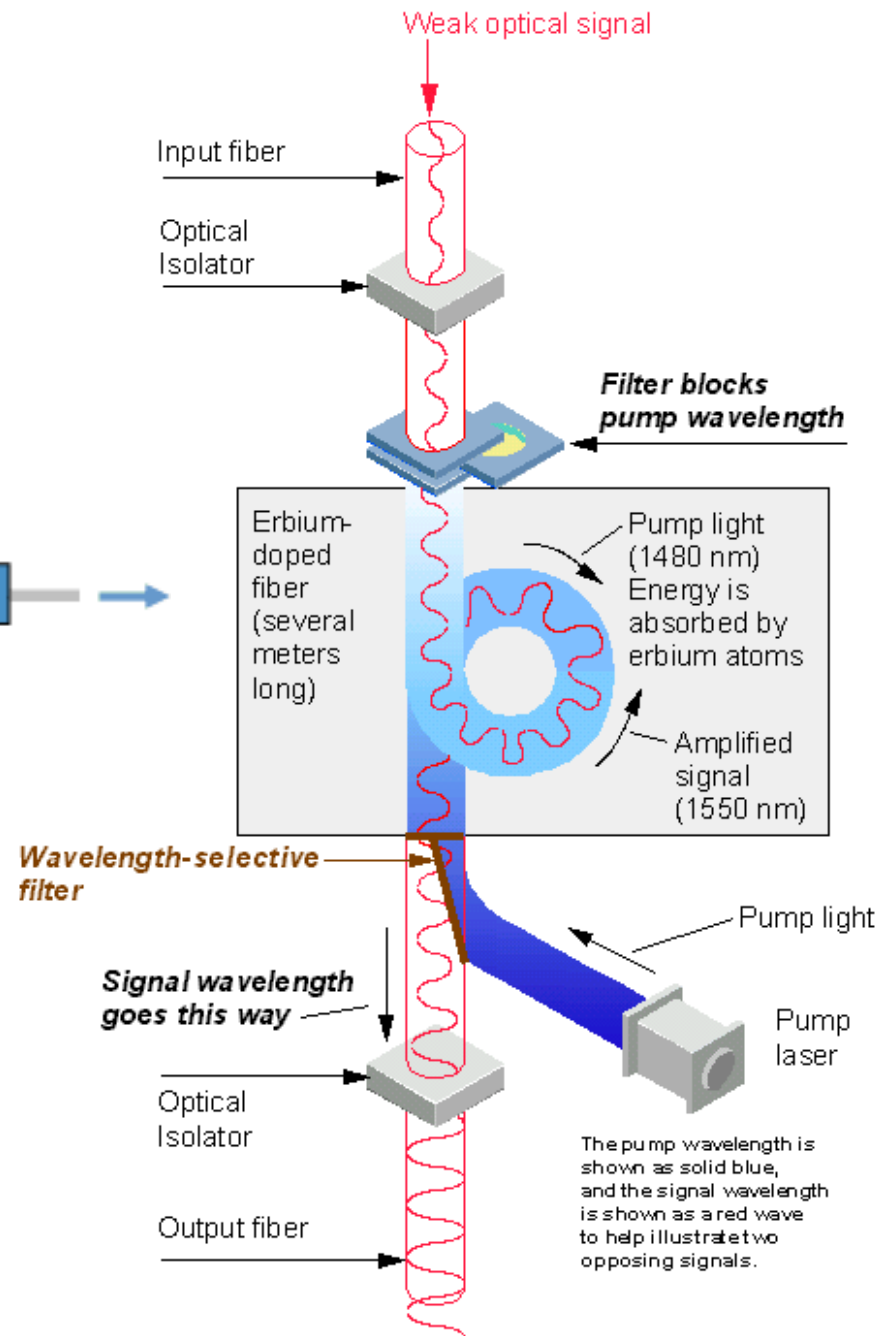
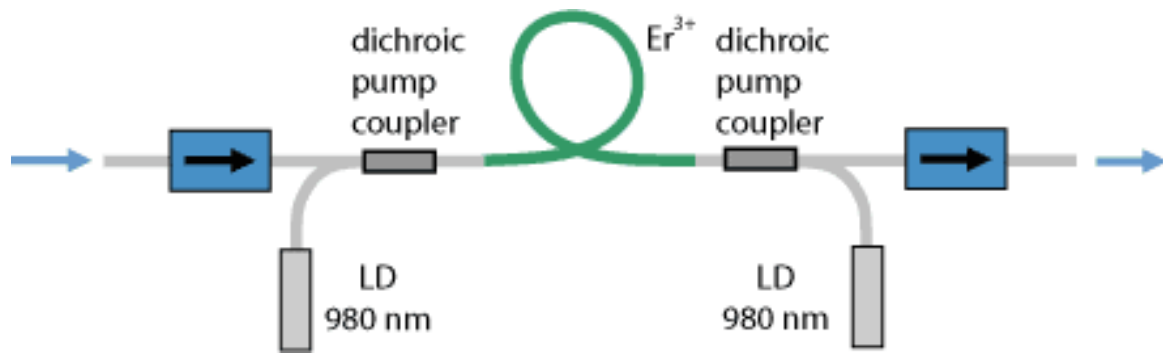


# EDFA

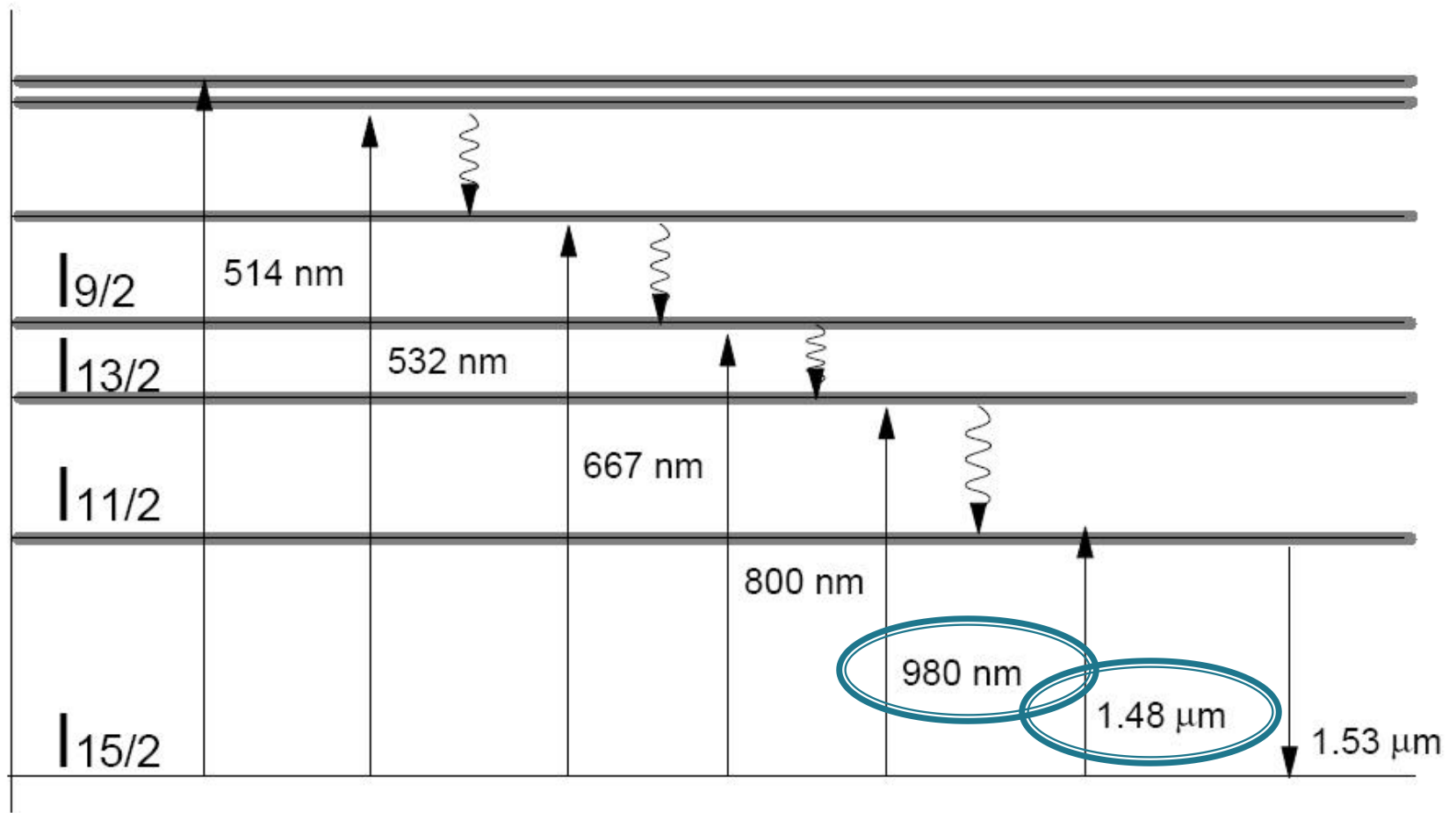
## ▶ Erbium Doped Fiber Amplifier



# EDFA

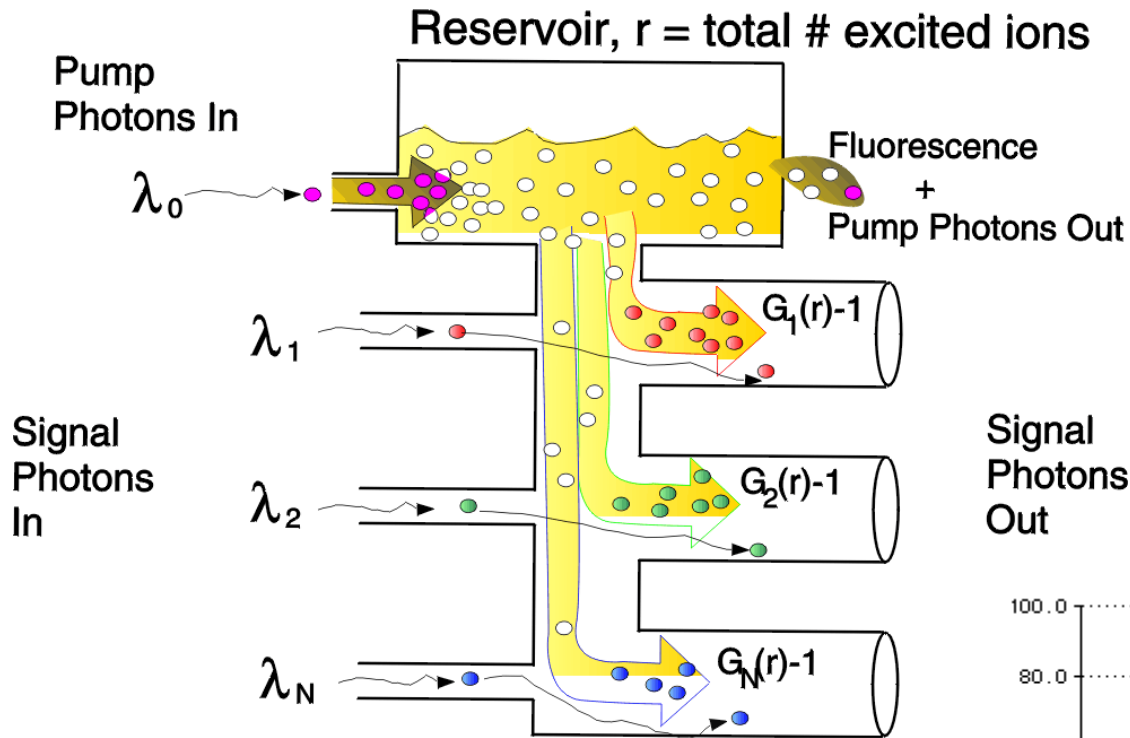


# EDFA – Erbium

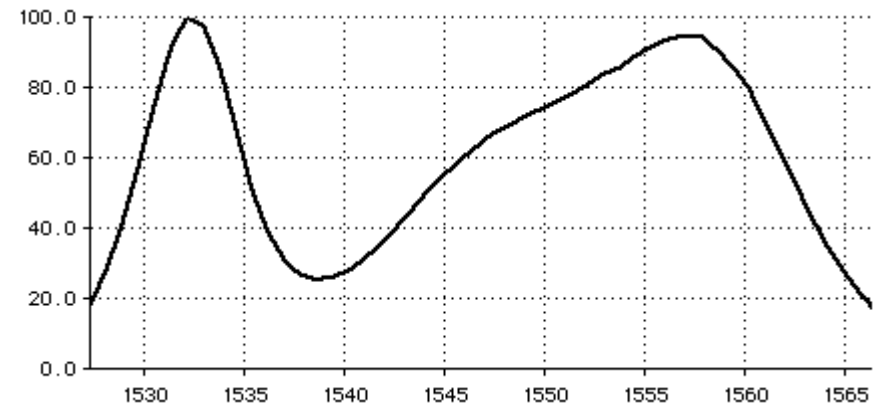


# EDFA

## How to think of an EDFA

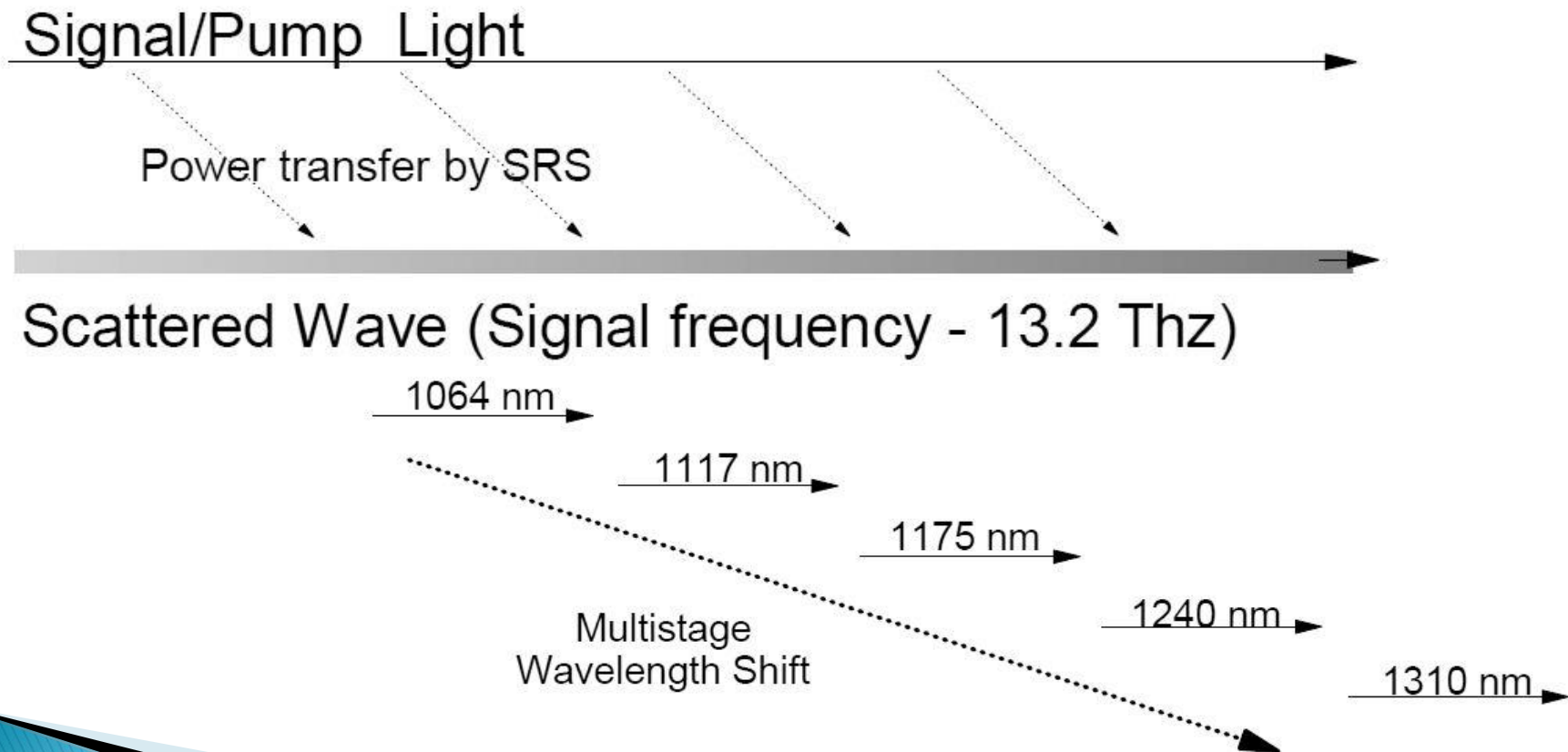


Signal Photons Out

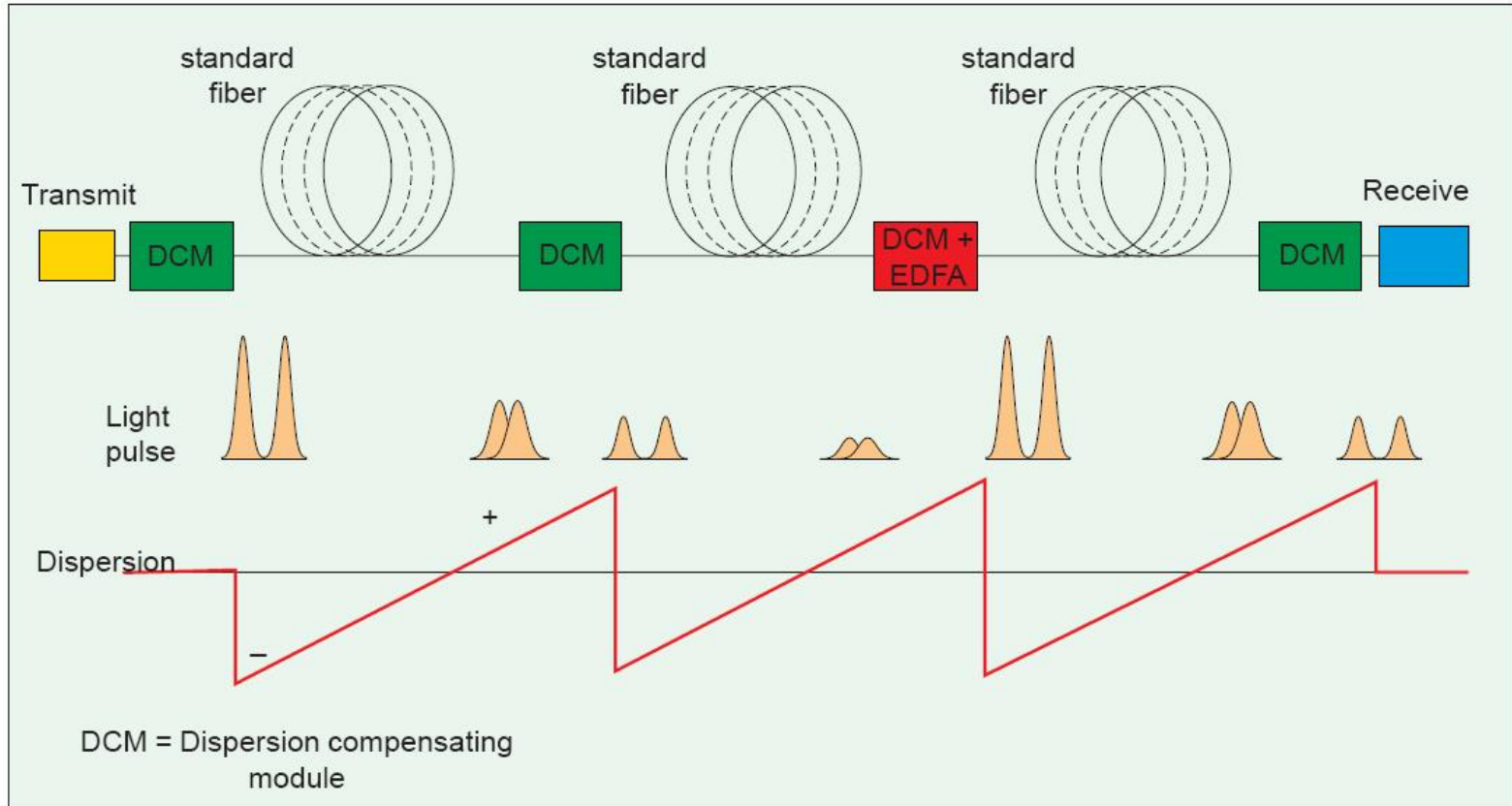


# Amplificator cu efect Raman

- ▶ Bazat pe efect Raman

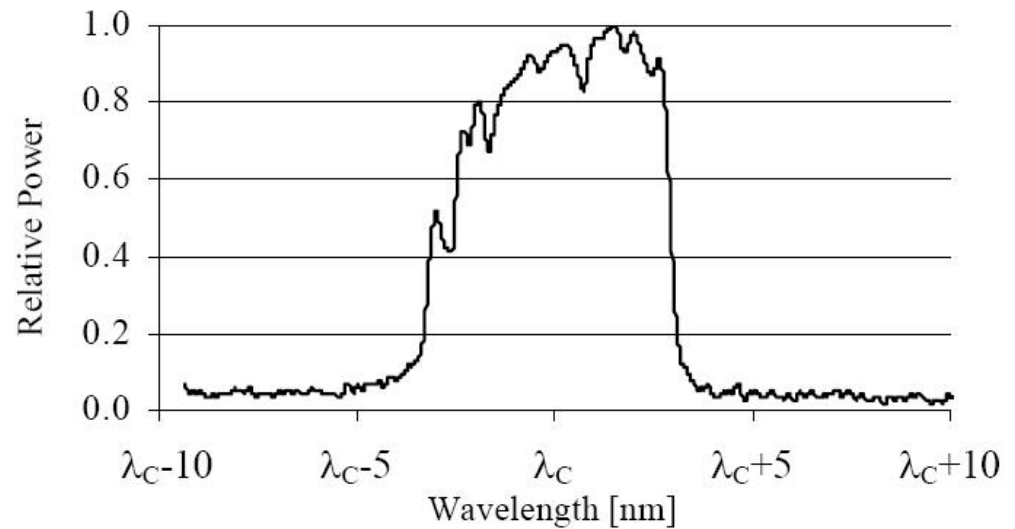
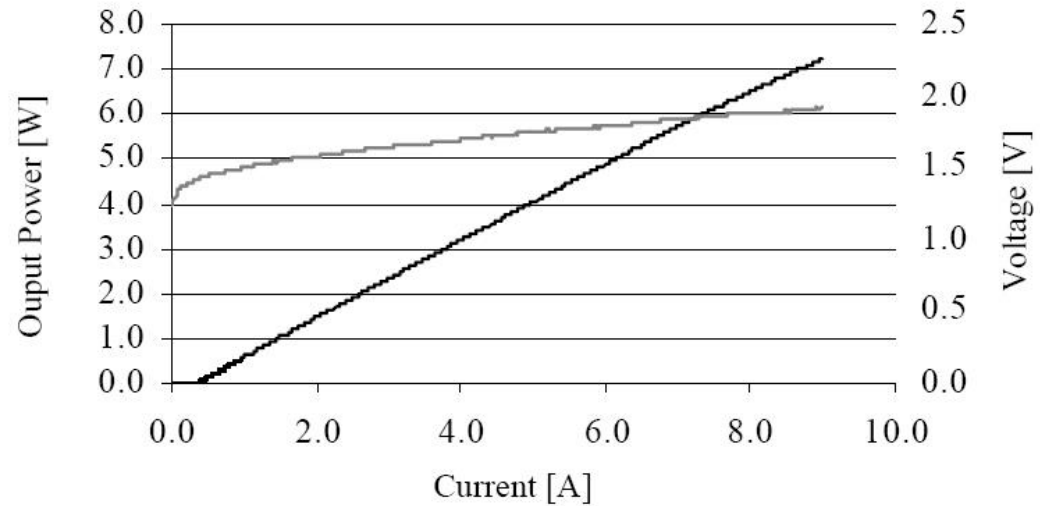
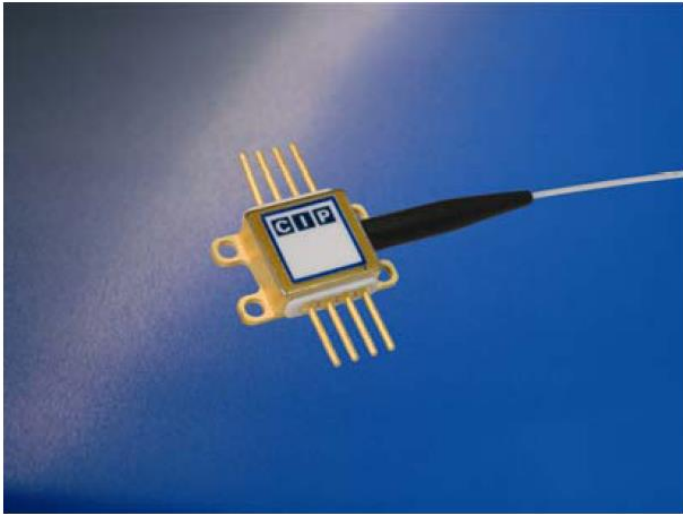


# Utilizare amplificatoare optice

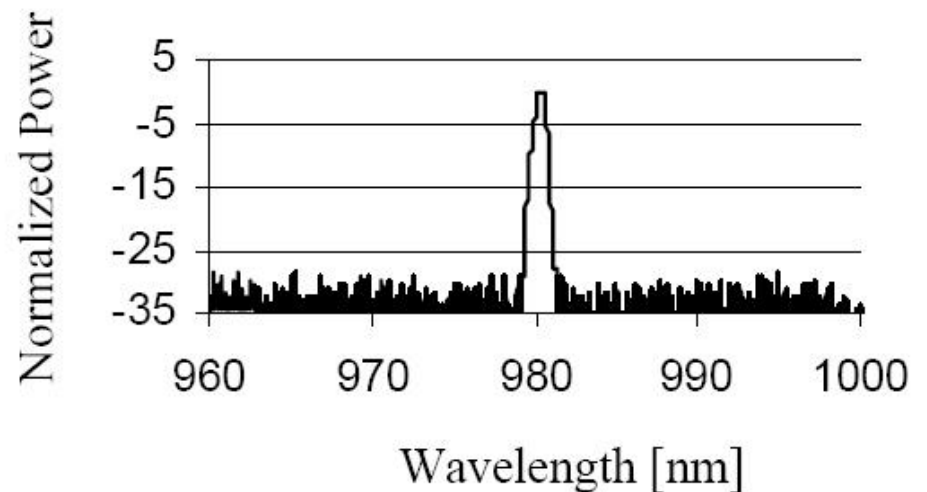
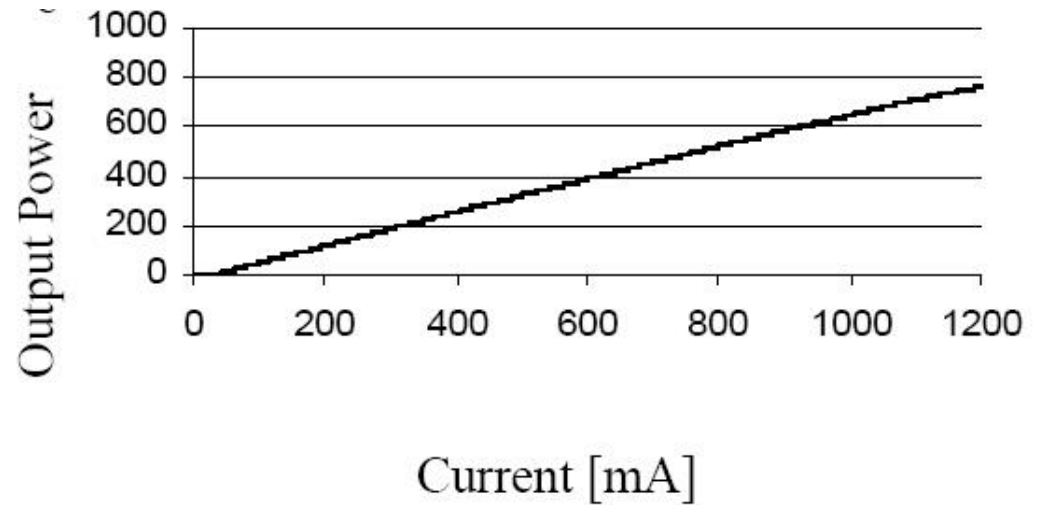
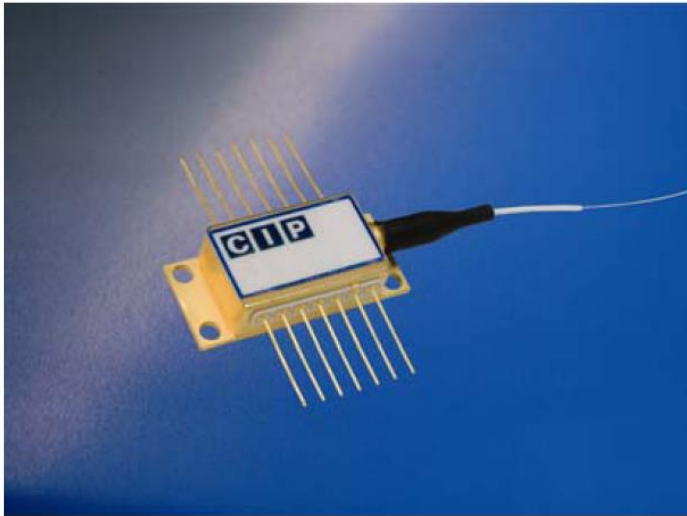




# 7W 980 nm Multimode Pump Laser

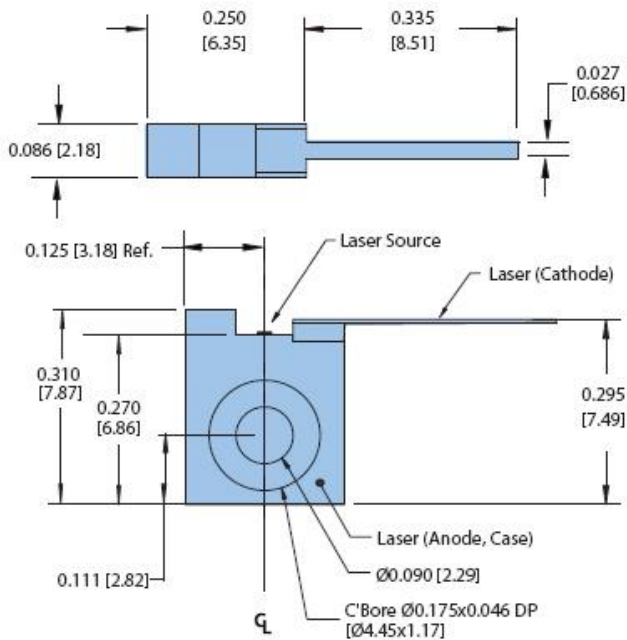


# 600mW 980 nm Singlemode Pump Laser

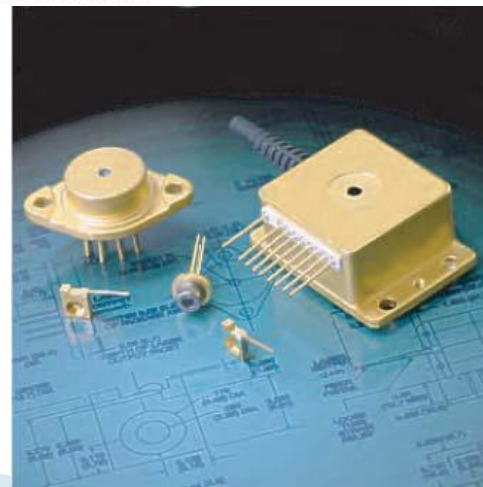
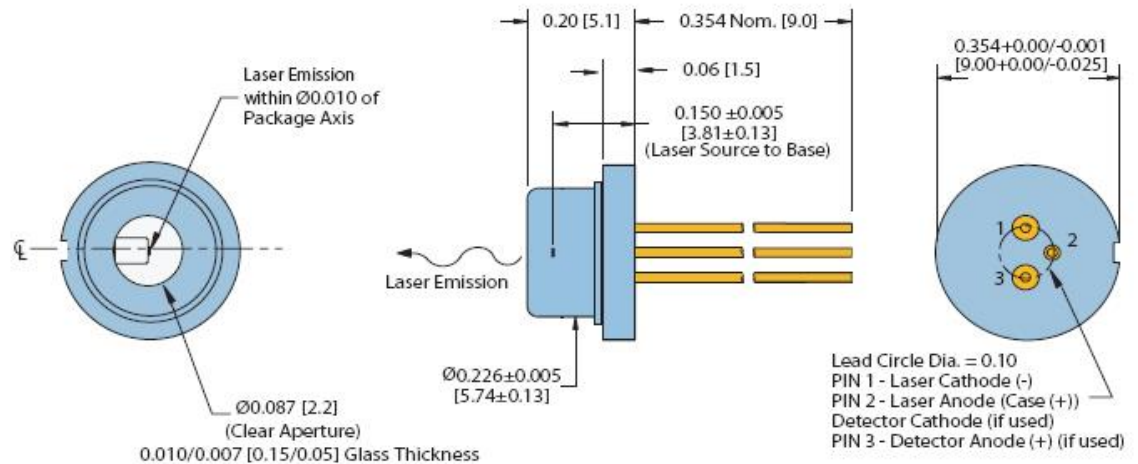


# 6 W, CW, 800nm

## C-Mount Package

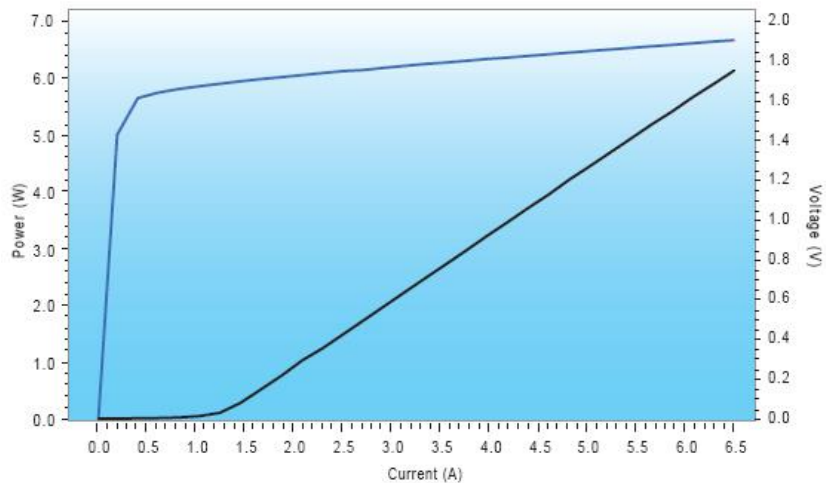


## 9mm Package

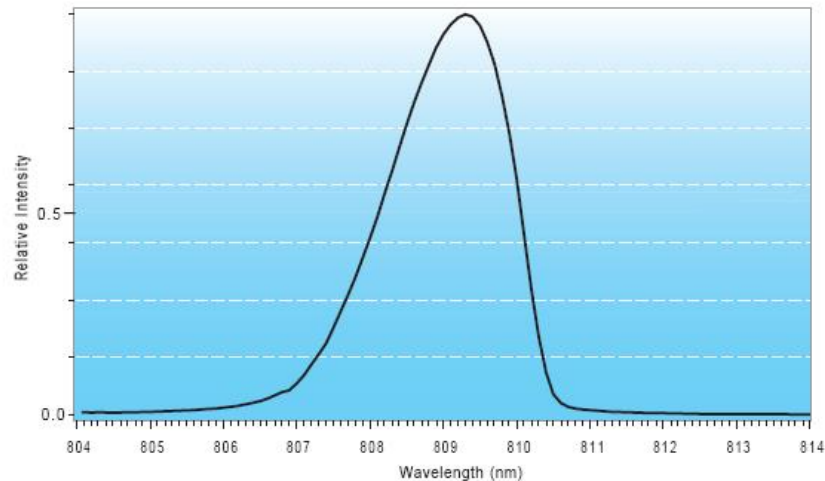


# 6 W, CW, 800nm

## Typical L/I, V/I Graph

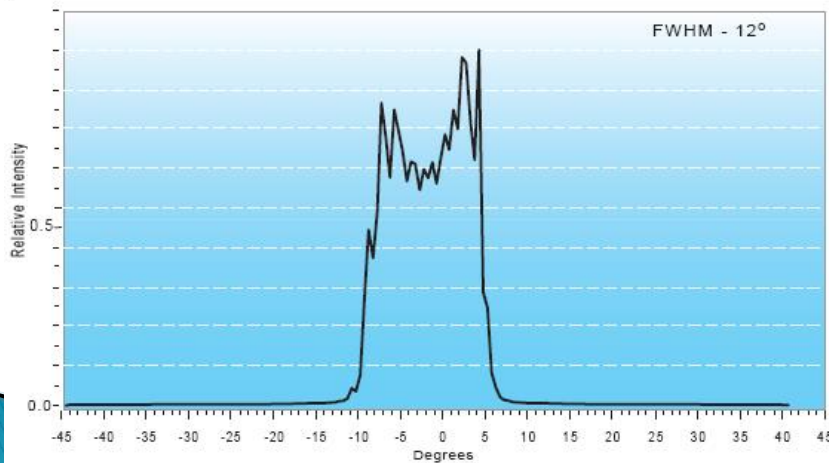


## Wavelength Distribution



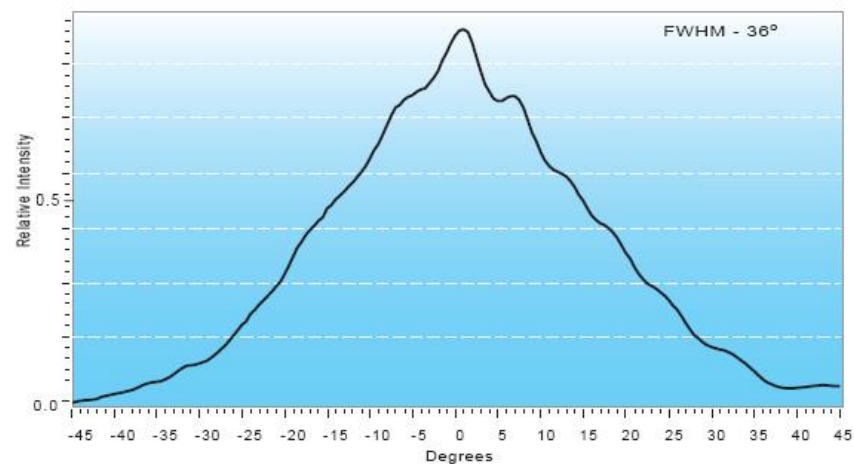
## Typical Beam Divergence

Parallel

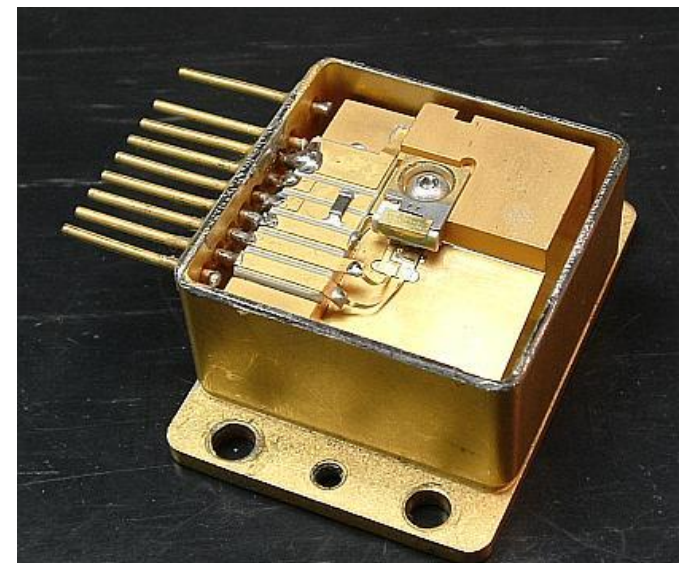
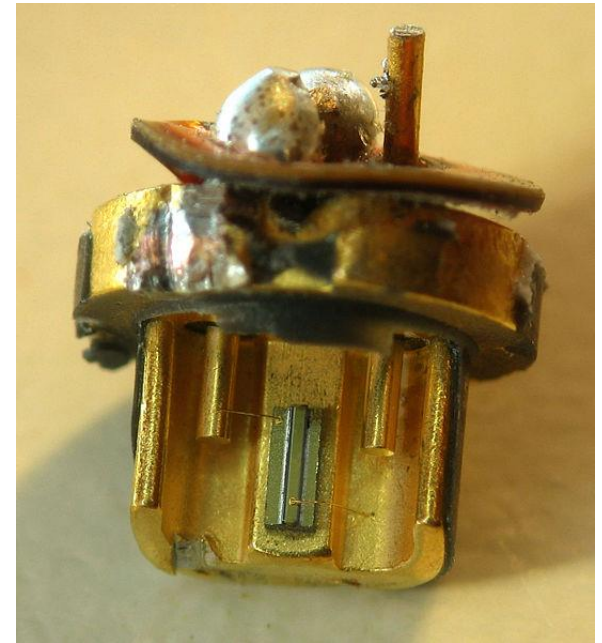
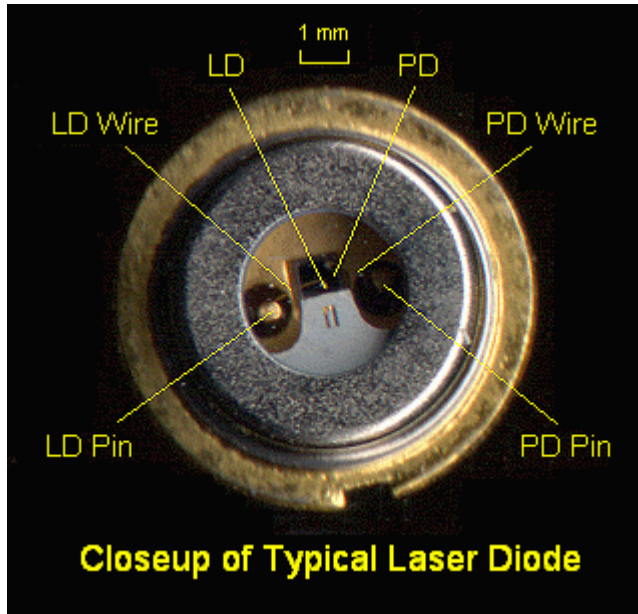


## Typical Beam Divergence

Perpendicular



# CW Laser, 650 nm



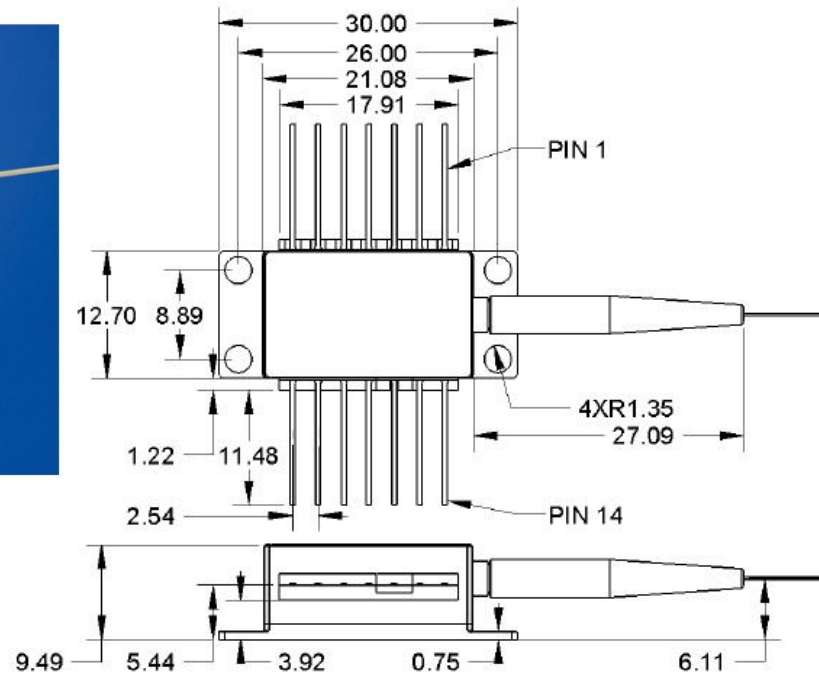
# Lungimi de unda

- ▶ **405 nm** – InGaN blue-violet laser, in Blu-ray Disc and HD DVD drives
- ▶ **445–465 nm** – InGaN blue laser multimode diode recently introduced (2010) for use in mercury-free high-brightness data projectors
- ▶ **510–525 nm** – Green diodes recently (2010) developed by Nichia and OSRAM for laser projectors.
- ▶ **635 nm** – AlGaInP better red laser pointers, same power subjectively twice as bright as 650 nm
- ▶ **650–660 nm** – GaInP/AlGaInP CDDVD, cheap red laser pointers
- ▶ **670 nm** – AlGaInP bar code readers, first diode laser pointers (now obsolete, replaced by brighter 650 nm and 671 nm DPSS)
- ▶ **760 nm** – AlGaInP gas sensing: O<sub>2</sub>
- ▶ **785 nm** – GaAlAs Compact Disc drives
- ▶ **808 nm** – GaAlAs pumps in DPSS Nd:YAG lasers (e.g., in green laser pointers or as arrays in higher-powered lasers)
- ▶ **848 nm** – laser mice
- ▶ **980 nm** – InGaAs pump for optical amplifiers, for Yb:YAG DPSS lasers
- ▶ **1,064 nm** – AlGaAs fiber-optic communication, DPSS laser pump frequency
- ▶ **1,310 nm** – InGaAsP, InGaAsN fiber-optic communication
- ▶ **1,480 nm** – InGaAsP pump for optical amplifiers
- ▶ **1,512 nm** – InGaAsP gas sensing: NH<sub>3</sub>
- ▶ **1,550 nm** – InGaAsP, InGaAsNSb fiber-optic communication
- ▶ **1,625 nm** – InGaAsP fiber-optic communication, service channel
- ▶ **1,654 nm** – InGaAsP gas sensing: CH<sub>4</sub>
- ▶ **1,877 nm** – GaInAsSb gas sensing: H<sub>2</sub>O
- ▶ **2,004 nm** – GaInAsSb gas sensing: CO<sub>2</sub>
- ▶ **2,330 nm** – GaInAsSb gas sensing: CO
- ▶ **2,680 nm** – GaInAsSb gas sensing: CO<sub>2</sub>
- ▶ **3,030 nm** – GaInAsSb gas sensing: C<sub>2</sub>H<sub>2</sub>
- ▶ **3,330 nm** – GaInAsSb gas sensing: CH<sub>4</sub>

# 1550nm DFB Laser

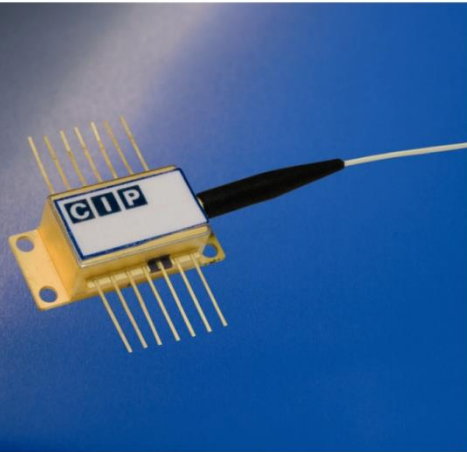
## Mechanical Drawing

All units in mm

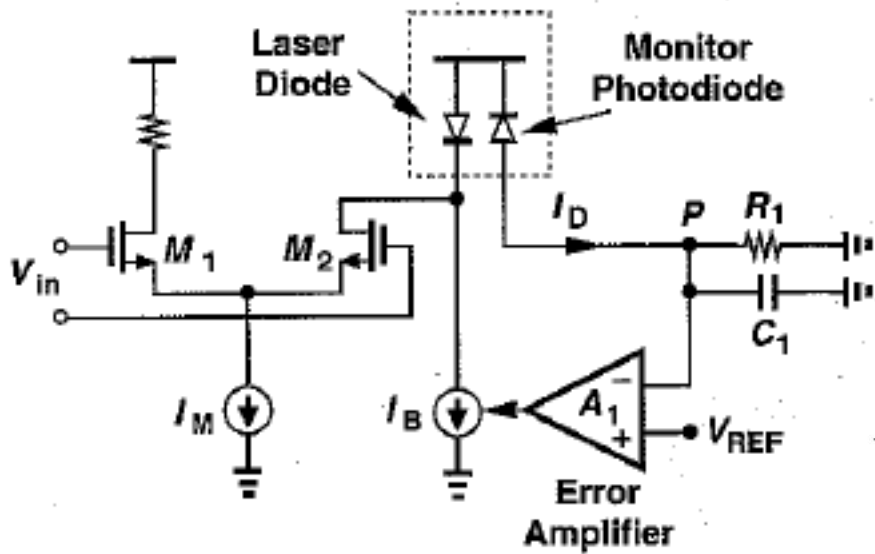


## Pin out

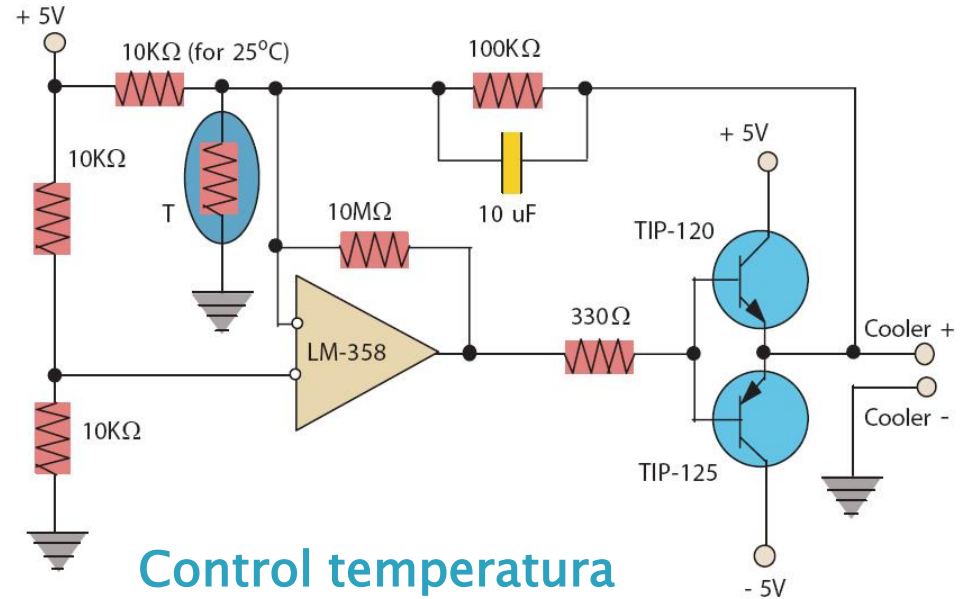
Pin	Description
1	Thermistor
2	Thermistor
3	Laser Cathode (Bias)
4	Monitor PD Anode
5	Monitor PD Cathode
6	TEC +
7	TEC -
8	Case GND, Laser Anode
9	Case GND, Laser Anode
10	Case GND, Laser Anode
11	Case GND, Laser Anode
12	Laser Cathode (modulation)
13	Case GND, Laser Anode
14	Case GND, Laser Anode



# Control dioda LASER



Control putere optica

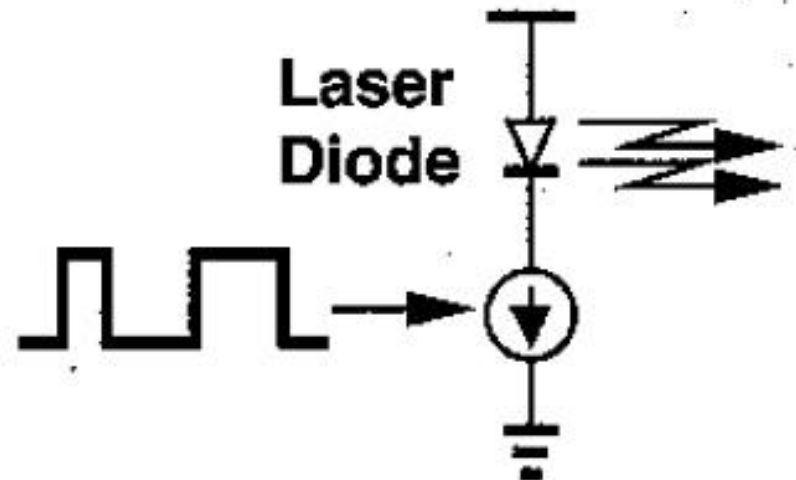


Control temperatura



# Dioda LASER

- ▶ Ca și în cazul LED, pentru DL intensitatea luminoasă emisă este o funcție de curentul prin dioda
  - aproape exclusiv, DL sunt controlate în curent
  - controlul în curent are avantajul unei viteze mai mari de lucru



# Dioda LASER

- ▶ Cerinte pentru driver-ele de diode laser
  - viteza mare de basculare pentru minimizarea interferentei intersimbol
  - curent mare de iesire
  - capacitatea de a rezista la variatiile de tensiune pe dioda Laser
- ▶ Cerintele sunt dificil de respectat deoarece sunt contradictorii
  - viteza mare presupune micșorarea dimensiunii componentelor
  - micșorarea dimensiunii
    - scade tensiunea de strapungere
    - scade capabilitatea de curent/putere disipata

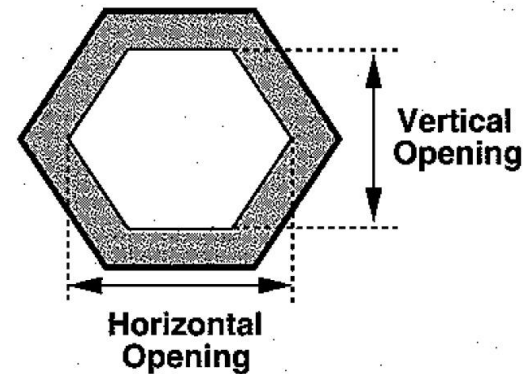
# Caracteristici driver-e DL

## ▶ Viteza

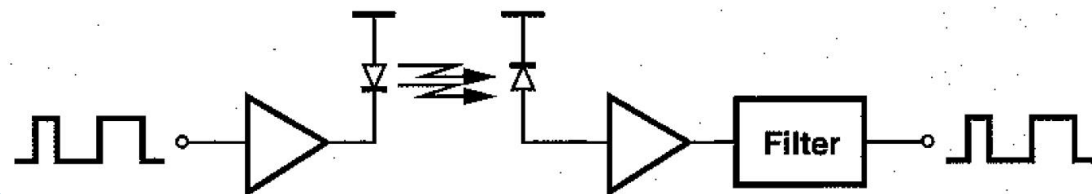
- caracterizata de timpii de crestere si de cadere
- suma acestora trebuie sa fie mult mai mica decat perioada de bit la viteza nominala de lucru

## ▶ Testarea vitezei de lucru

- standardizata
- “eye diagram”



(a)

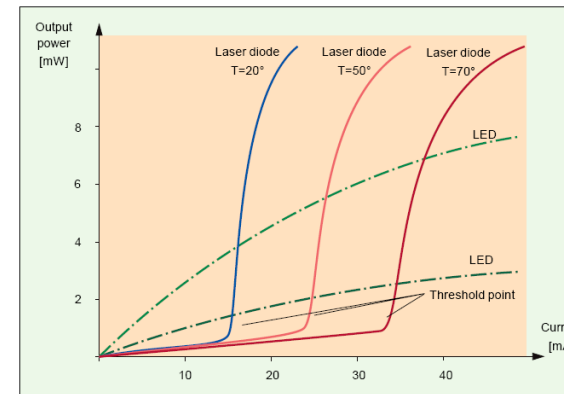


(b)

# Caracteristici driver-e DL

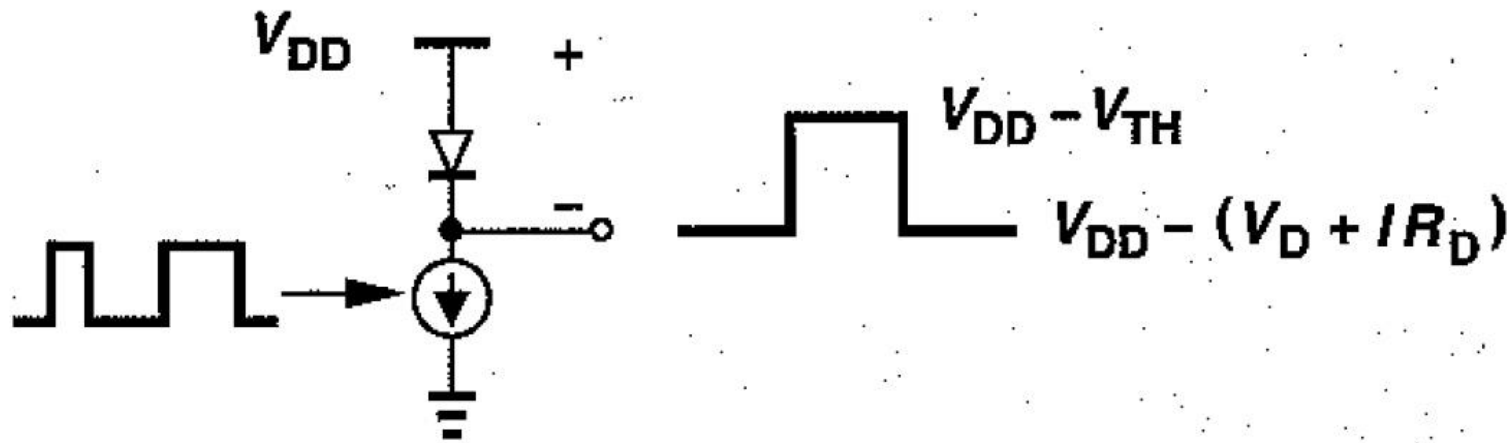
## ▶ Curent de iesire

- laserele trebuie polarizate in vecinatatea pragului, astfel incat o mica variatie de curent sa poata deschide dioda
- driver-ele de DL trebuie sa poata furniza:
  - un curent de “polarizare”
  - un curent de “modulatie”
- Curentul de “polarizare” (~ de prag) variaza cu temperatura si varsta diodei extrem de mult
- Curentul de “modulatie” (semnal) nu depinde de aceste elemente deoarece pentru DL
  - pragul depinde de temperatura si varsta
  - panta este aproximativ constanta



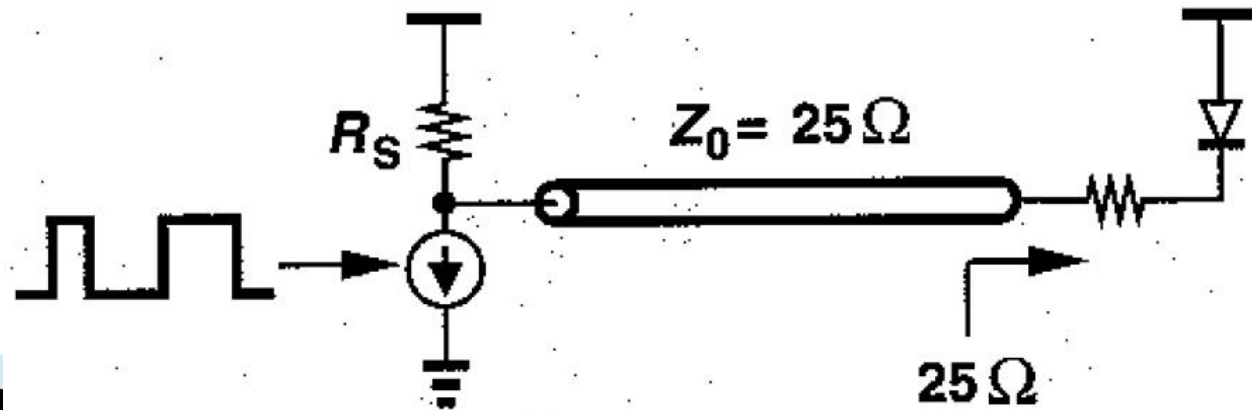
# Caracteristici driver-e DL

- ▶ Variatii de tensiune pe dioda LASER
  - generate de variatiile mari de curent si rezistenta interna a diodei



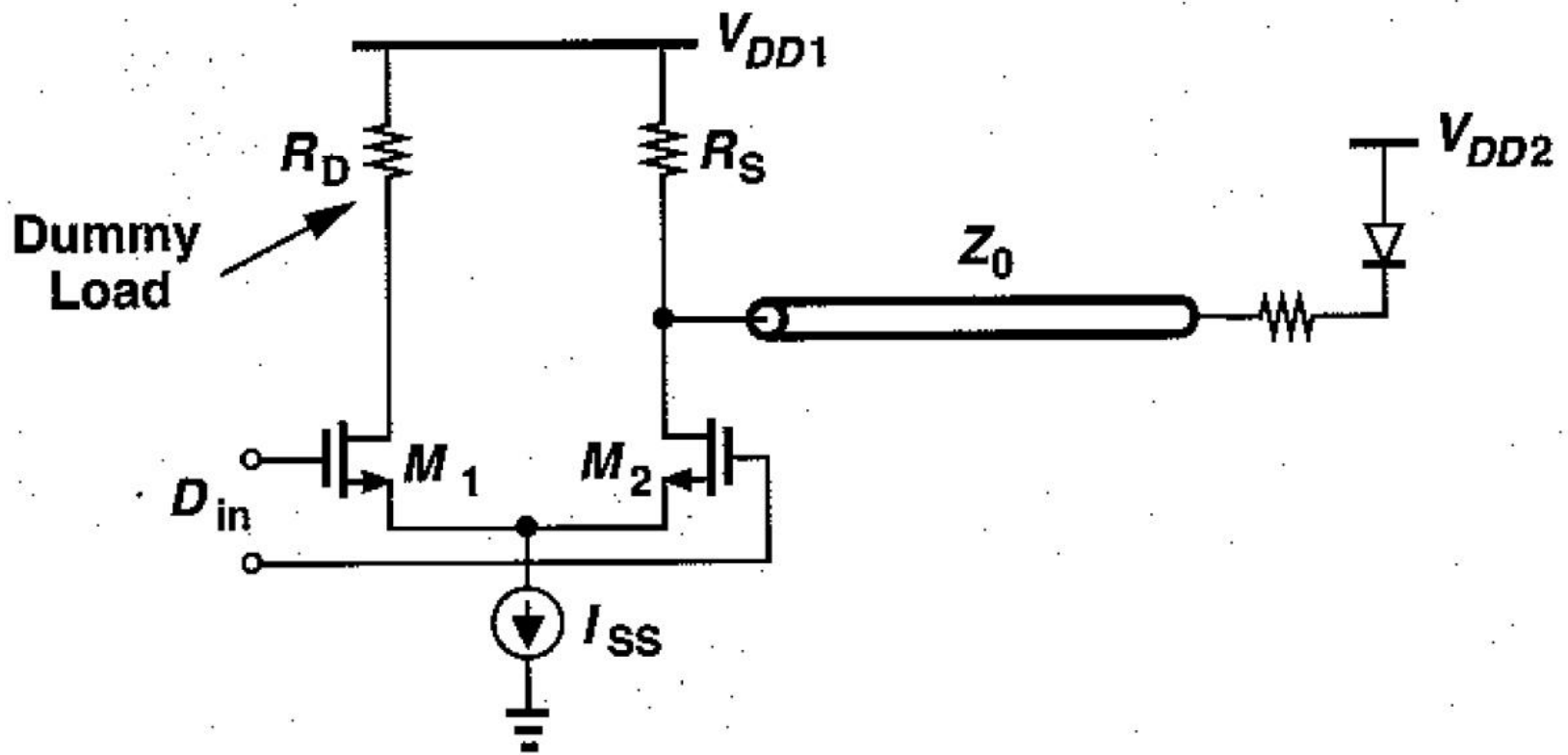
# Caracteristici driver-e DL

- ▶ Impedante de intrare si iesire
- ▶ Se lucreaza la viteze mari (1Gb/s, 10Gb/s)
  - se aplica considerente de proiectare a circuitelor de microunde
  - Intrarea in amplificator are tipic o impedanta de  $50\Omega$
  - Iesirea trebuie adaptata la impedanta diodei Laser
    - daca aceasta impedanta e prea mica, se creste la valori adecvate ( $\sim 25\Omega$ ) prin introducerea unui rezistor in serie



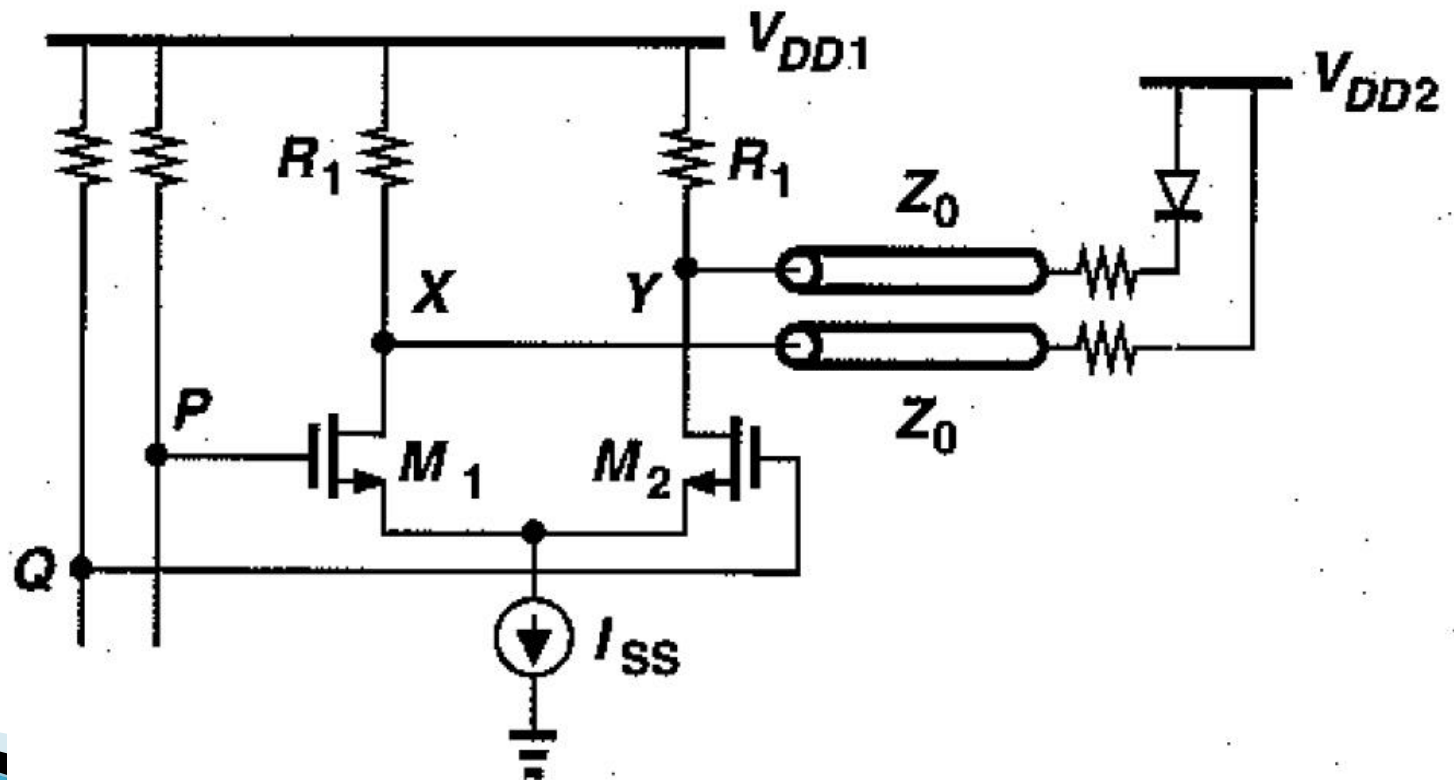
# Principii de proiectare

- ▶ Tipic etajul de iesire se realizeaza diferential



# Principii de proiectare

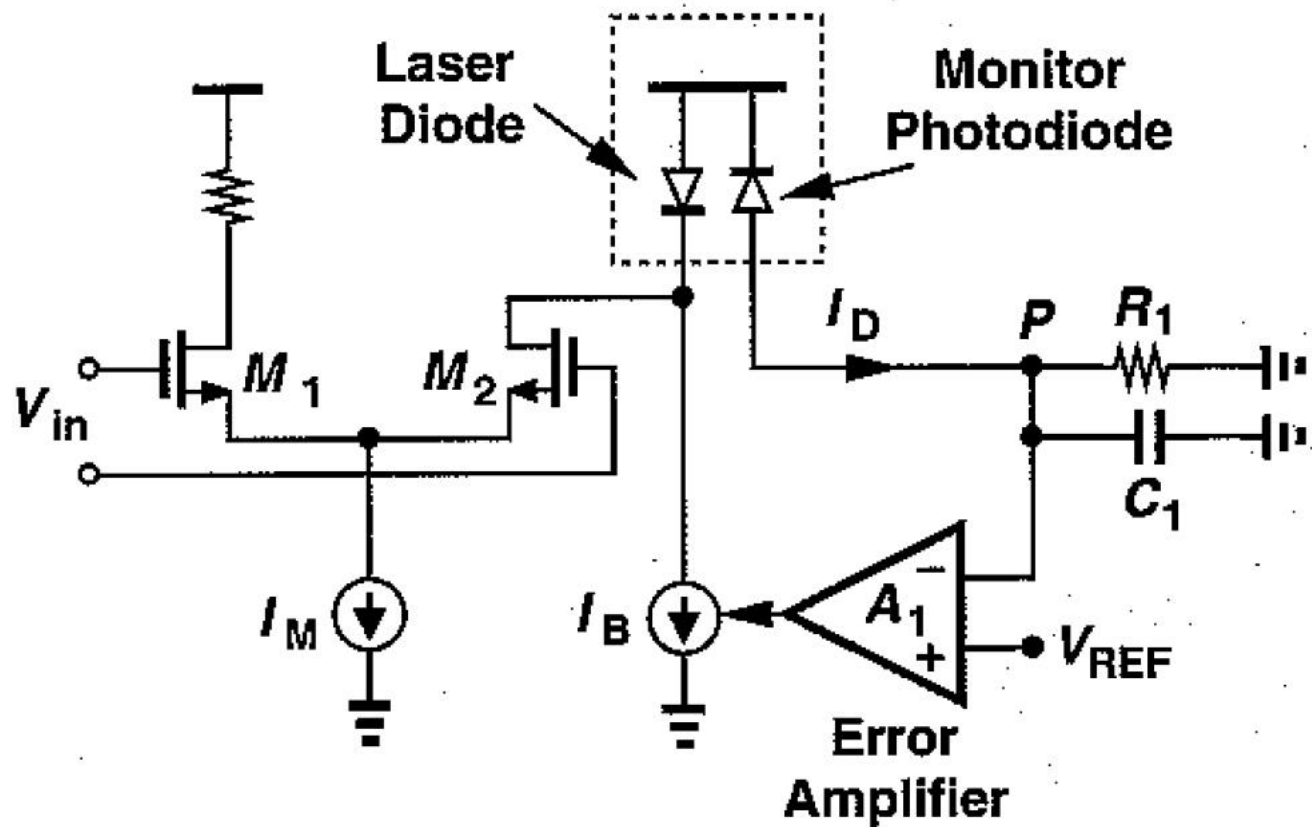
- ▶ La viteze mari se utilizeaza tipic tranzistoare unipolare si etajul diferential se realizeaza simetric





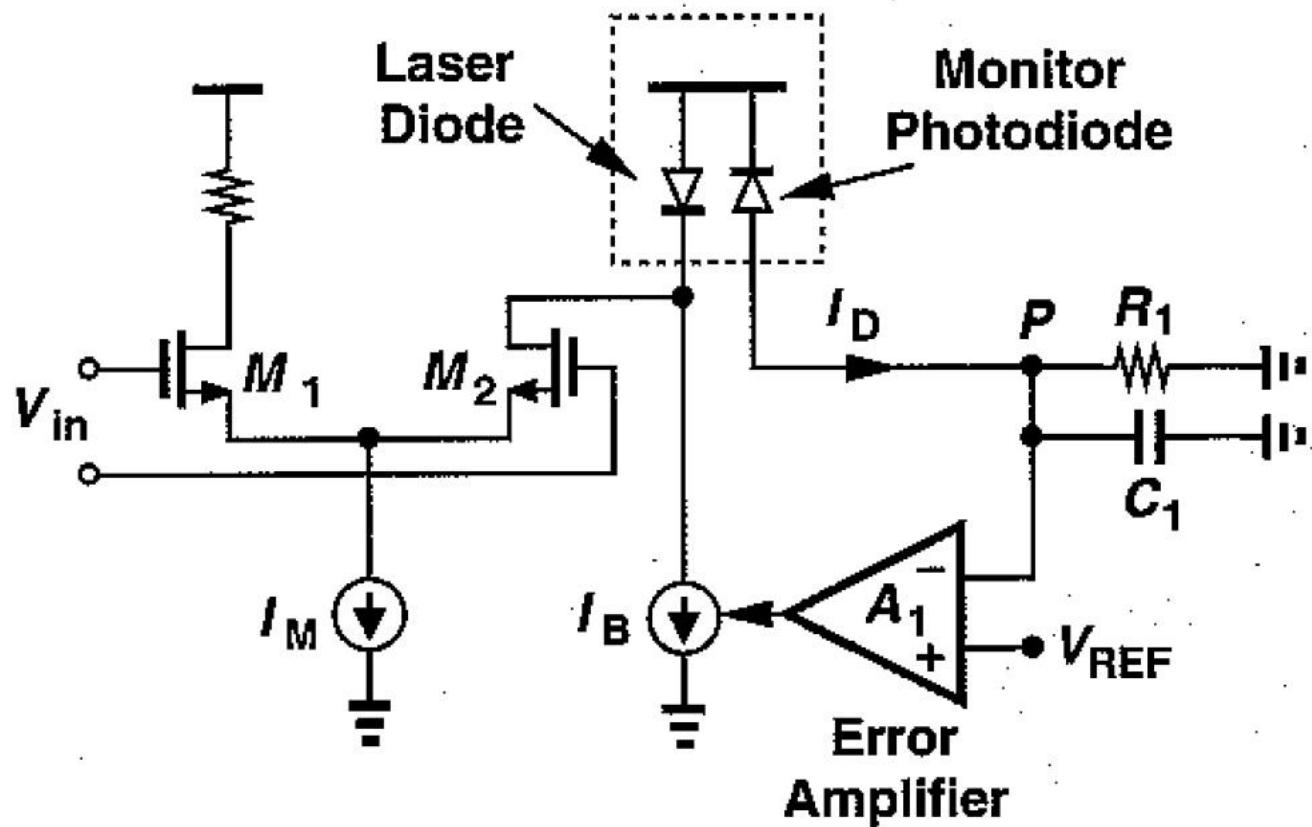
# Controlul puterii in DL

- ▶ Necesara datorita variatiei curentului de “polarizare”



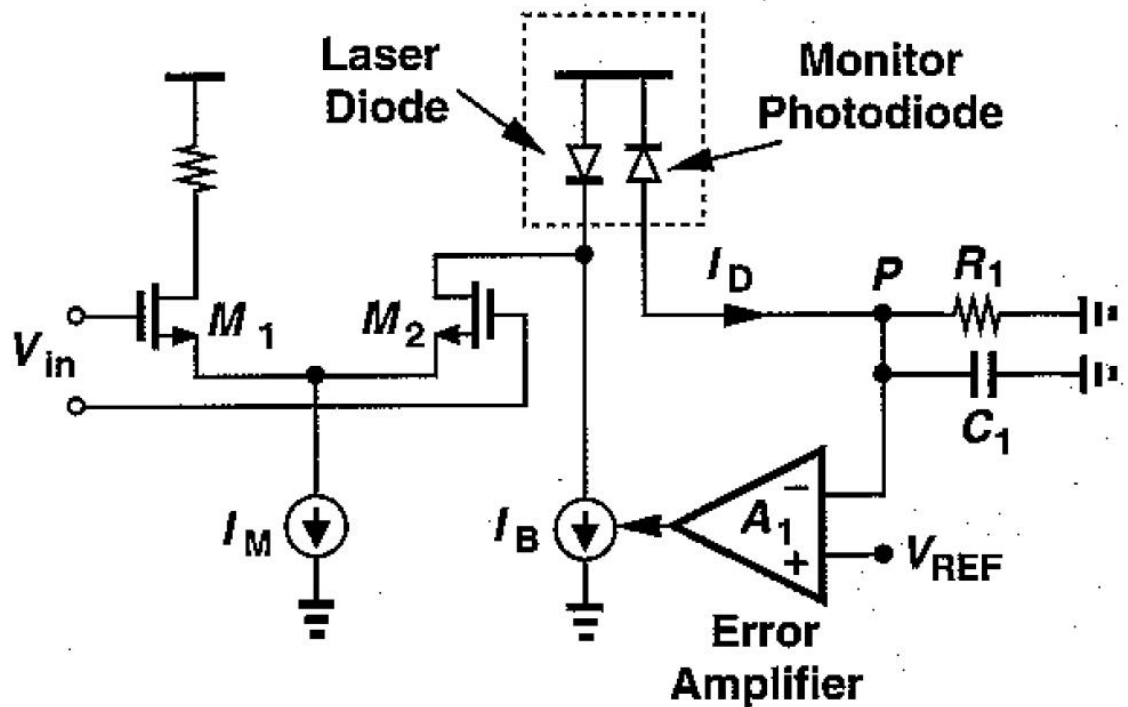
# Controlul puterii in DL

- ▶ circuitul RC din schema de reglaj a curentului de polarizare realizeaza o filtrare trece sus a semnalului



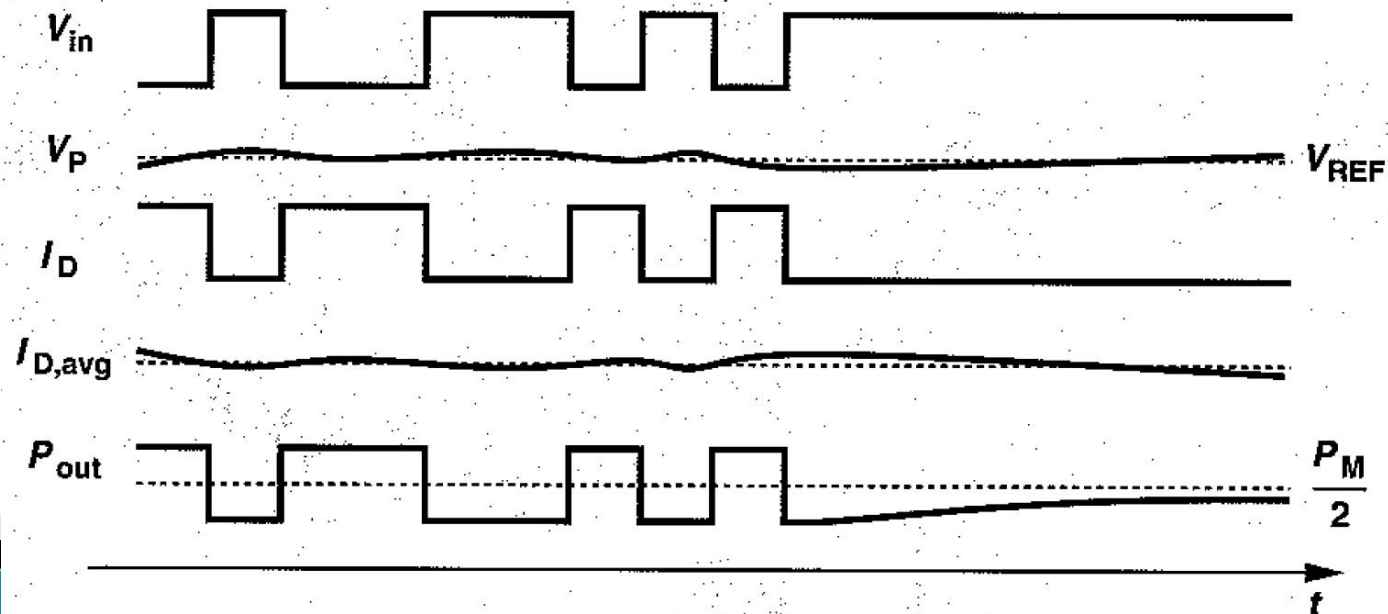
# Controlul puterii in DL

- ▶ La frecvente prea mici de lucru bucla de reatie e suficient de rapida pentru a urmari si anula curentul de semnal



# Controlul puterii in DL

- ▶ Bucla de reactie are efect si in cazul unei suite lungi de biti 1 transmisi
  - In acest caz, la limita curentul emis de dioda laser in starea OFF ajunge jumătate din curentul corespunzator starii ON
  - Capacitatea de filtrare din bucla trebuie aleasa mare pentru a minimiza acest efect
  - daca valoarea e prea ridicata e necesara o capacitate externa circuitului integrat



# Fotodioda

## Capitolul 9

# Cuprins

- ▶ **Lumina ca undă electromagnetică** (ecuațiile lui Maxwell, ecuația undelor, parametri de propagare)
- ▶ **Elemente de fotometrie și radiometrie** (mărimi energetice/luminoase)
- ▶ **Fibra optică** (realizare, principiu de funcționare, atenuare, dispersie, banda de frecvență)
- ▶ **Cabluri optice** (tehnologie, conectori, lipire – splice)
- ▶ **Proiectare sistemică a legăturii pe fibra optică** (bandă de frecvență, balanța puterilor)
- ▶ **Emitătoare optice** (LED și dioda laser – realizare fizică și funcționare)
- ▶ **Receptoare optice** (dioda PIN, dioda cu avalanșă – realizare fizică și funcționare)
- ▶ **Amplificatoare transimpedanță** (parametri, scheme tipice, TIA în buclă deschisă, cu reacție, diferențiale, control automat al câștigului)
- ▶ **Realizarea circuitelor pentru controlul emițătoarelor optice** (parametri, scheme tipice, controlul puterii, multiplexoare)
- ▶ **Dispozitive de captare a energiei solare** (principiu de funcționare, utilizare, proiectare )

# Detectori optici

## ▶ Cerinte

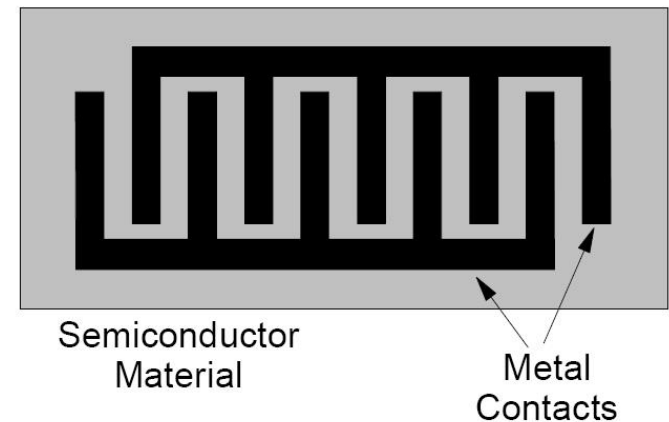
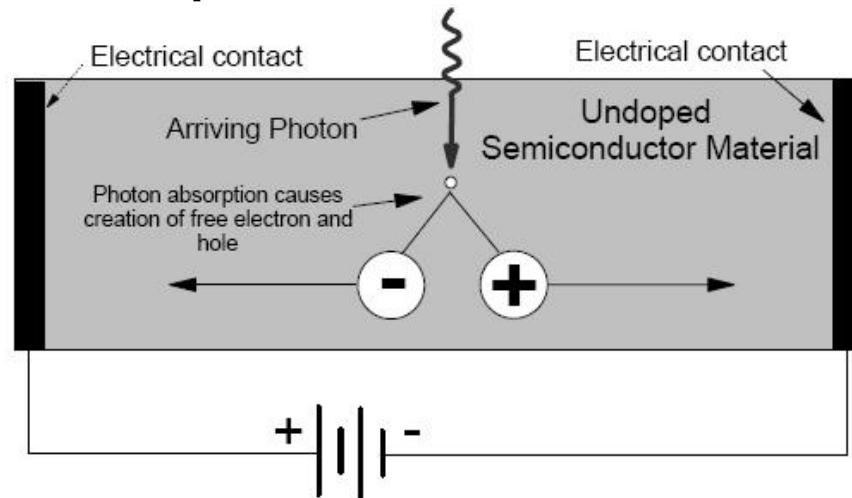
- eficienta crescuta a conversiei optic/electric
- zgomot redus
- raspuns uniform la diferite lungimi de unda
- viteza de raspuns ridicata
- liniaritate

## ▶ Principii de operare

- fotoconductori  $R = R(P_o)$
- fototranzistori  $I_B = I_B(P_o)$
- fotodiode  $I = I(P_o)$ 
  - pn
  - pin
  - pin cu multiplicare in avalansa
  - Schottky

# Fotoconductor

## ▶ Principiu

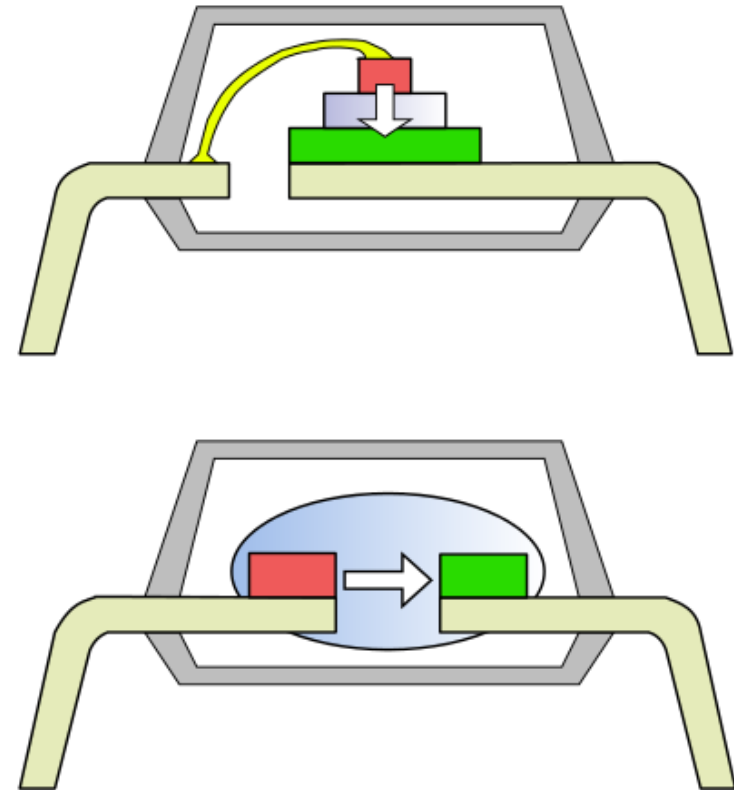
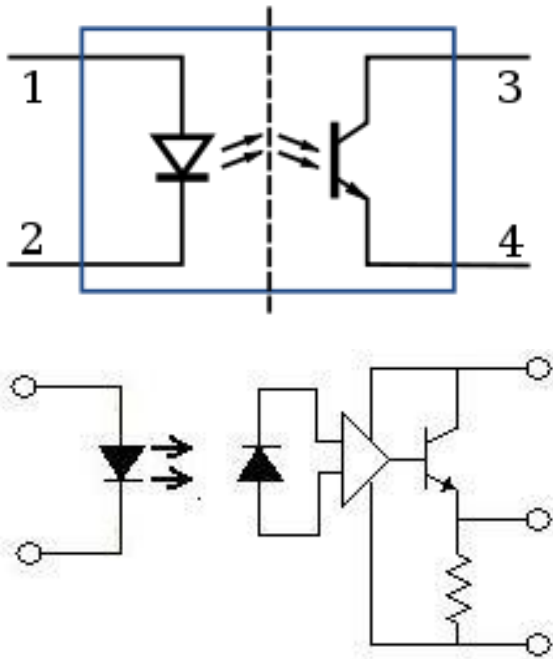


- ▶ Dispozitive Metal Semiconductor Metal (filtru interdigital) sunt utilizate pentru usurinta de fabricare si integrare in aplicatii mai putin pretentioase



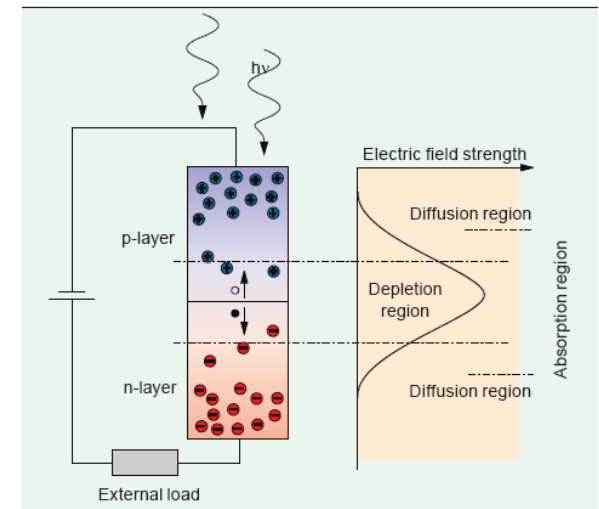
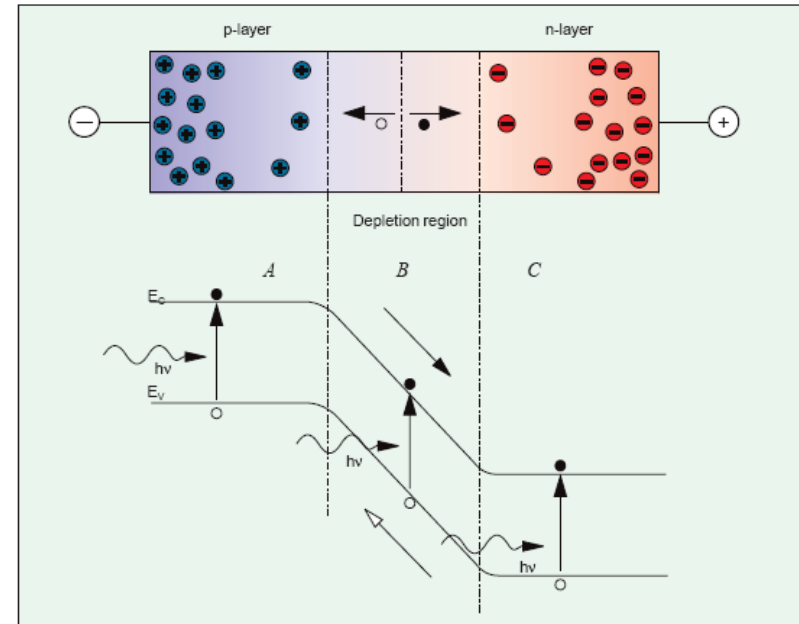
# Optocuploare

- ▶ utilizate pentru a oferi izolare electrica intre doua sectiuni ale unui circuit
  - izolarea portiunii de comanda si/sau masura de partea de “forta” a circuitului



# Fotodioda – Principiul de operare

- ▶ Jonctiunea pn este polarizata invers
- ▶ Lumina este absorbita in regiunea golita de purtatori, un foton absorbit generand o pereche electron-gol
- ▶ Sarcinile sunt separate de campul electric existent in regiunea golita si genereaza un curent in circuitul exterior



# Fotodioda – Principiul de operare

- ▶ Energia necesara pentru eliberarea unei perechi electron gol

$$h\nu = \frac{hc}{\lambda} \geq E_g$$

- ▶ Lungime de unda de taiere

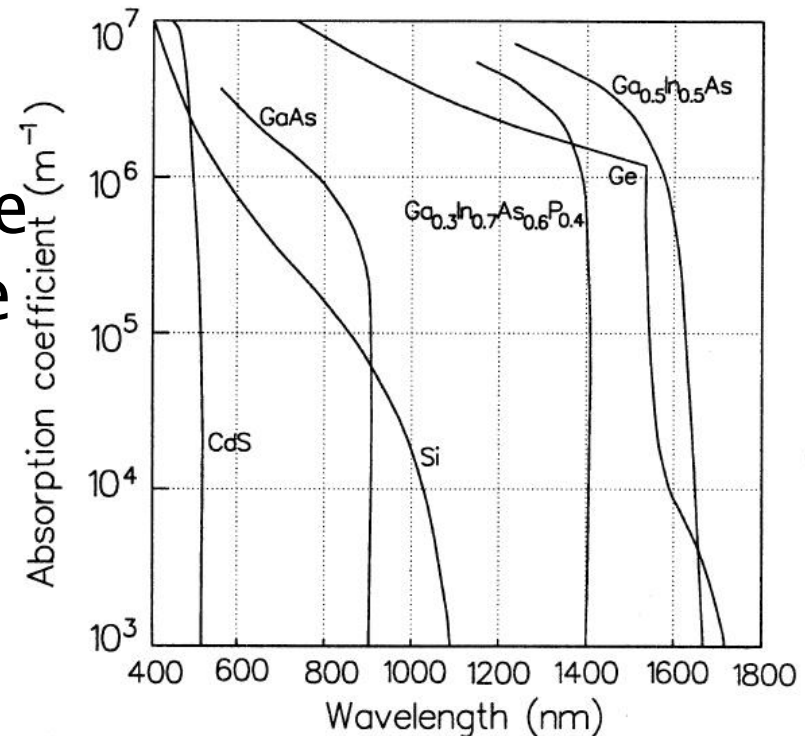
$$\lambda_{\max} = \frac{hc}{E_g}$$

- ▶ Puterea optica absorbita in zona golita de purtatori (w) aflata la o adincime d in interiorul dispozitivului

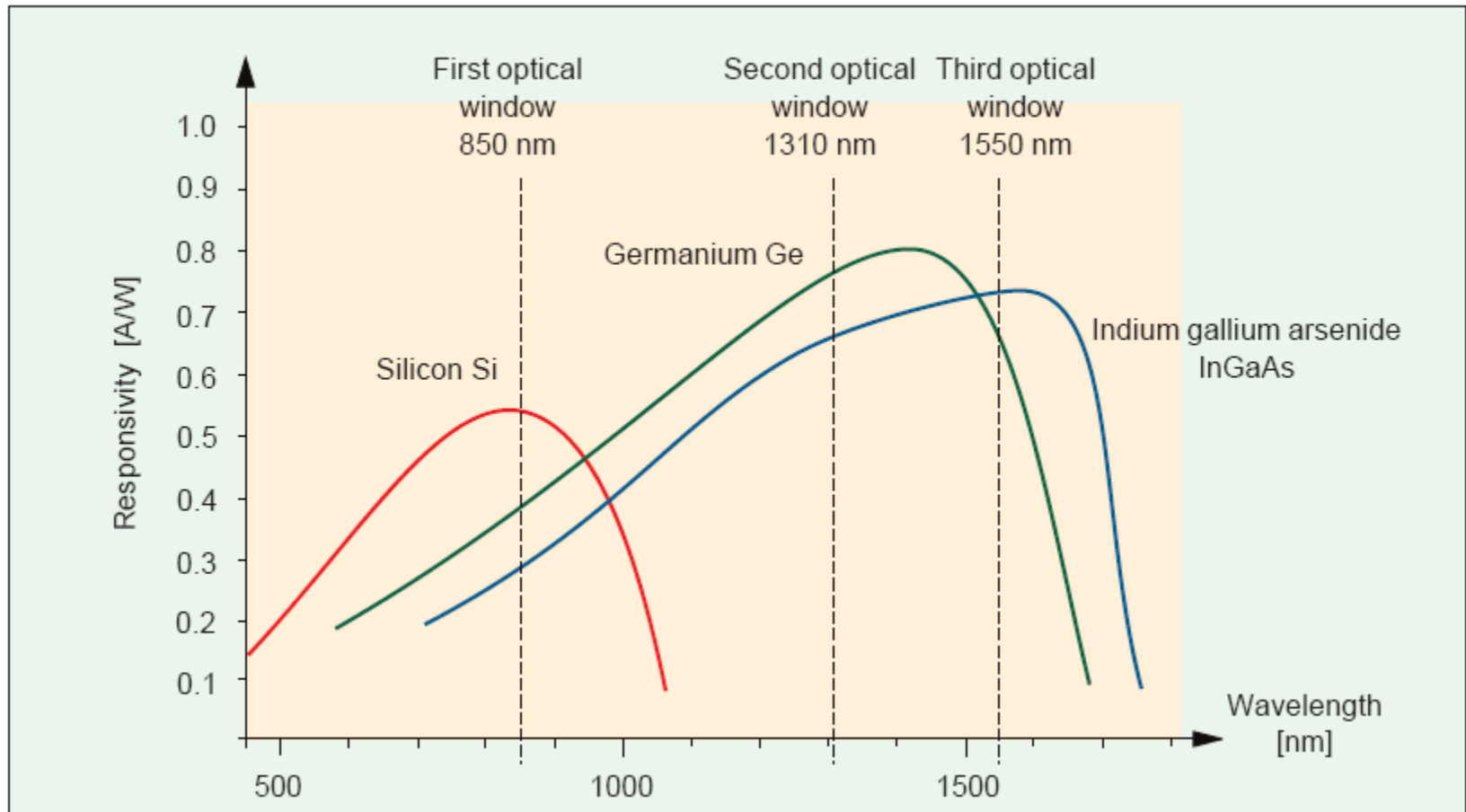
$$P(w) = P_i \cdot e^{-\alpha \cdot d} \cdot (1 - e^{-\alpha \cdot w}) \cdot (1 - R_f)$$

# Fotodioda – Principiul de operare

- ▶ Coeficientul de absorbtie pentru materialele uzuale
- ▶ Valoarea mare a coeficientului de absorbtie la lungimi de unda reduse implica scaderea rezponzivitatii
- ▶ Ca urmare comportarea **tuturor** materialelor este de tip trece banda



# Material utilizate pentru fotodiode



# Fotodioda – Marimi caracteristice

- ▶ Eficienta cuantica – raportul dintre numărul de perechi electron–gol generate și numărul de fotoni incidenti

$$\eta = \frac{n_e}{n_f}$$

- ▶ In unitatea de timp numarul de fotoni depinde de puterea optica, iar numarul de electroni impune curentul generat

$$\eta = \frac{I/e}{P/h\nu}$$

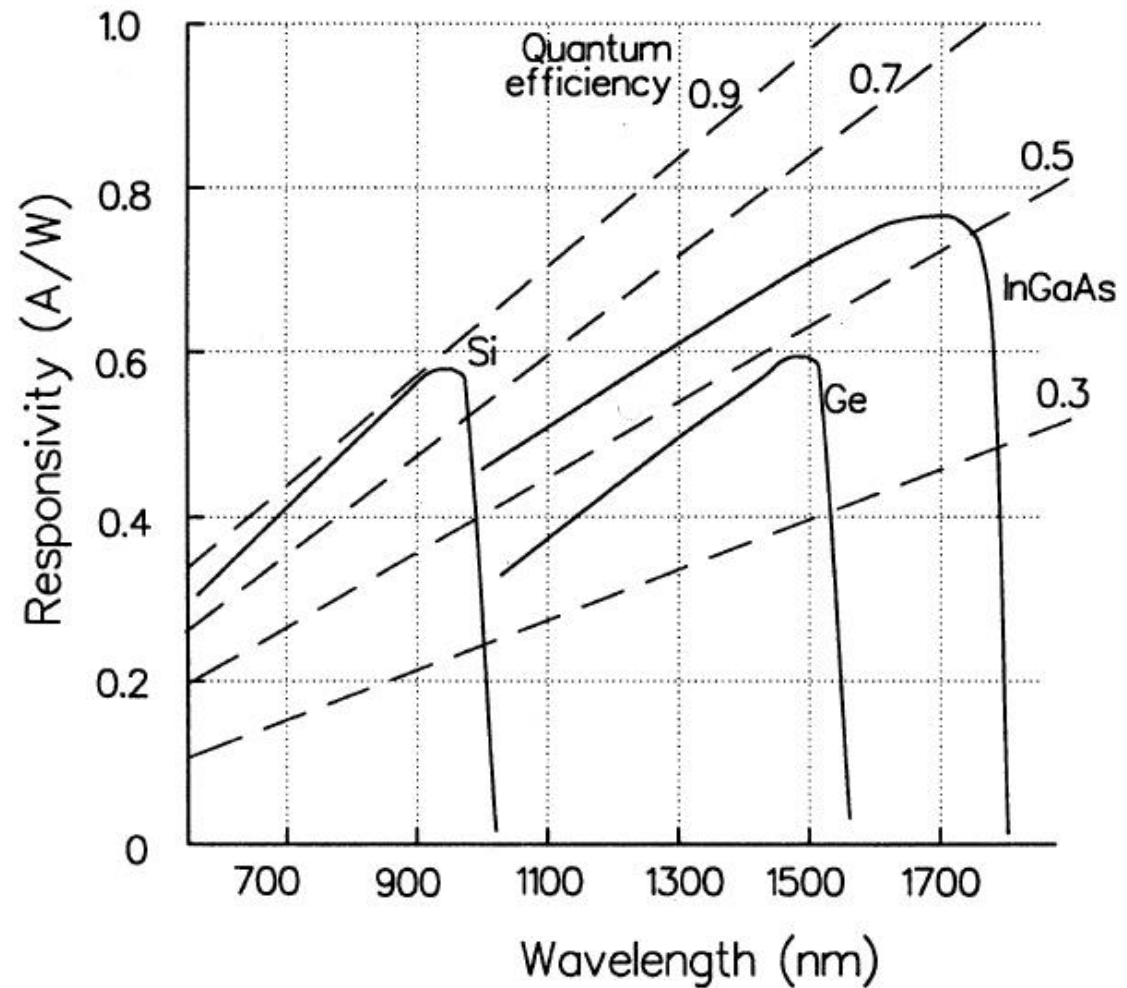
- ▶ Responzivitatea

$$R = \frac{I}{P_o} = \frac{\eta \cdot e \cdot \lambda}{hc}$$

$$R = 0.8 \cdot \eta \cdot \lambda [\mu m] \left[ \frac{A}{W} \right]$$

# Fotodiode - marimi karakteristik

$$R = \frac{I}{P_o} = \eta \cdot \frac{e}{hc} \cdot \lambda$$



# Material utilizate pentru fotodiode

Material	$\lambda$ [ $\mu\text{m}$ ]	Responsivitate [A/W]	Viteza [ns]	Curent de intuneric
Si	0.85	0.55	3	1
Si	0.65	0.4	3	1
InGaAs	1.3–1.6	0.95	0.2	3
Ge	1.55	0.9	3	66

- ▶ Dezavantajul major pentru Ge este curentul de intuneric mare

Material	$E_g$ (eV)
GaAs	1.43
GaSb	0.73
$\text{GaAs}_{0.88}\text{Sb}_{0.12}$	1.15
Ge	0.67
InAs	0.35
InP	1.35
$\text{In}_{0.53}\text{Ga}_{0.47}\text{As}$	0.75
$\text{In}_{0.14}\text{Ga}_{0.86}\text{As}$	1.15
Si	1.14



# Curent de intuneric

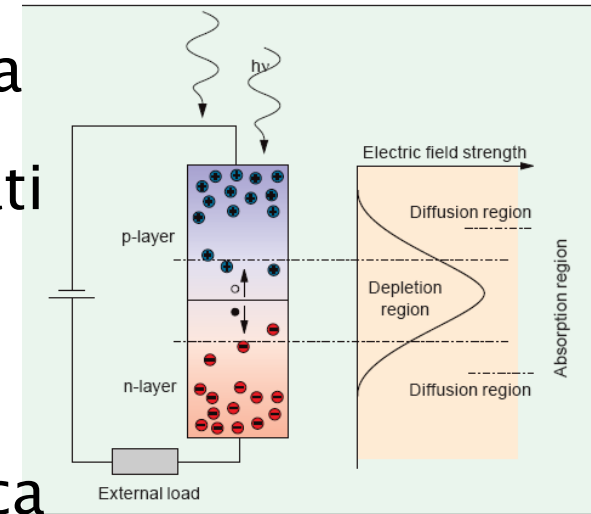
- ▶ Curentul invers al jonctiunii p-n, datorat agitatiei termice, prezent in absenta iluminarii
- ▶ Constitutie o importanta sursa de zgomot (limiteaza aplicatiile Ge)

$$I_D = I_S \approx \frac{\beta \cdot kT}{eR_0}$$

- $\beta$  – coeficient de idealitate  $\beta = 1 \div 2$
- $R_0$  – rezistenta la intuneric a diodei (invers proportionala cu aria diodei)

# Fotodioda PIN

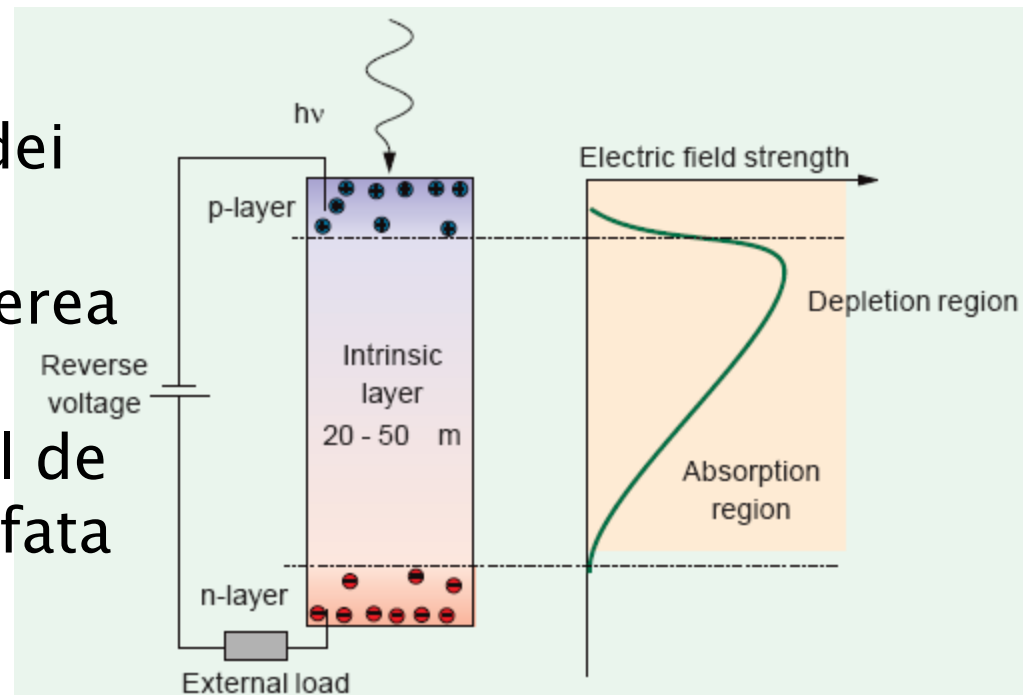
- ▶ Existenta campului electric in regiunea golita de purtatori face ca eventualii purtatori generati optic sa fie accelerati spre terminale pentru constituirea fotocurentului
- ▶ Problemele utilizarii diodei pn polarizate invers ca fotodetector sunt generate de adancimea extrem de mica a zonei golite ( $w$ )
- ▶ Puterea optica absorbita in interiorul acestei zone e in consecinta redusa
- ▶ Purtatorii generati inafara zonei de golire ajung eventual in zona golita si vor fi accelerati spre terminale, dar viteza fenomenului este prea redusa pentru aplicatii in comunicatii



$$P(w) = P_i \cdot e^{-\alpha \cdot d} \cdot (1 - e^{-\alpha \cdot w}) \cdot (1 - R_f)$$

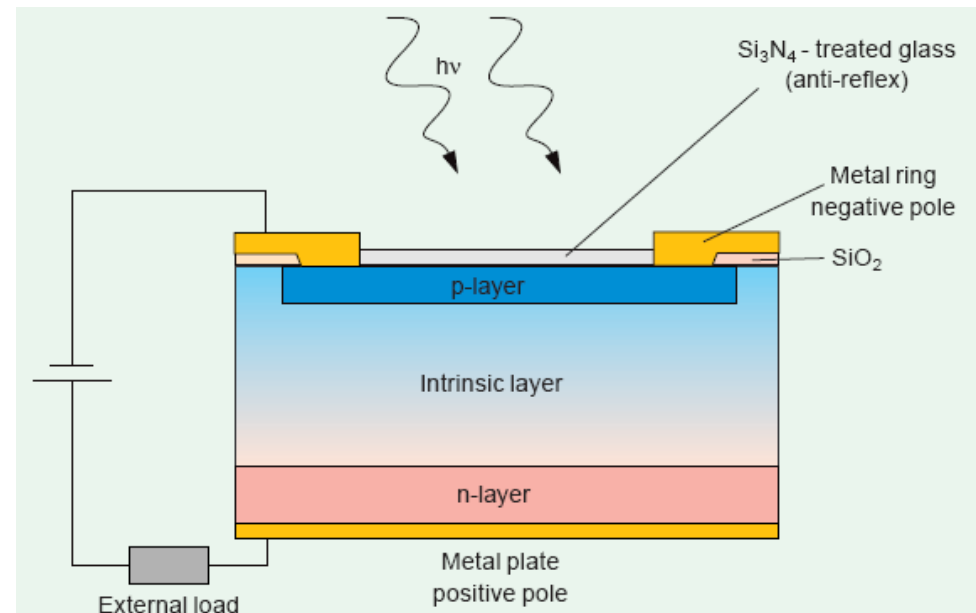
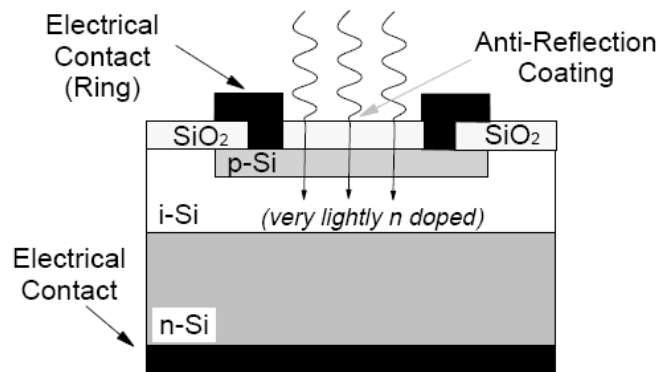
# Fotodioda PIN

- ▶ Solutia consta in introducerea unui strat foarte slab dopat (intrinsec) intre cele doua zone ale diodei
  - creste volumul de absorbtie deci creste sensibilitatea fotodiodei
  - capacitatea jonctiunii scade ducand la cresterea vitezei
  - este favorizat curentul de conductie (mai rapid) fata de cel de difuzie



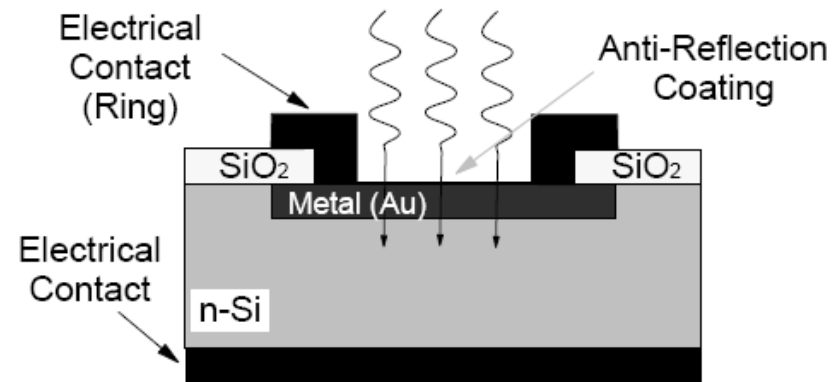
# Structura fotodiodei PIN

- ▶ tipic, adancimea stratului intrinsec este de 20–50 $\mu\text{m}$
- ▶ cresterea suplimentara a adancimii ar duce la cresterea timpului de tranzit
  - $w=20\mu\text{m} \rightarrow T_{tr} \cong 0.2\text{ns}$



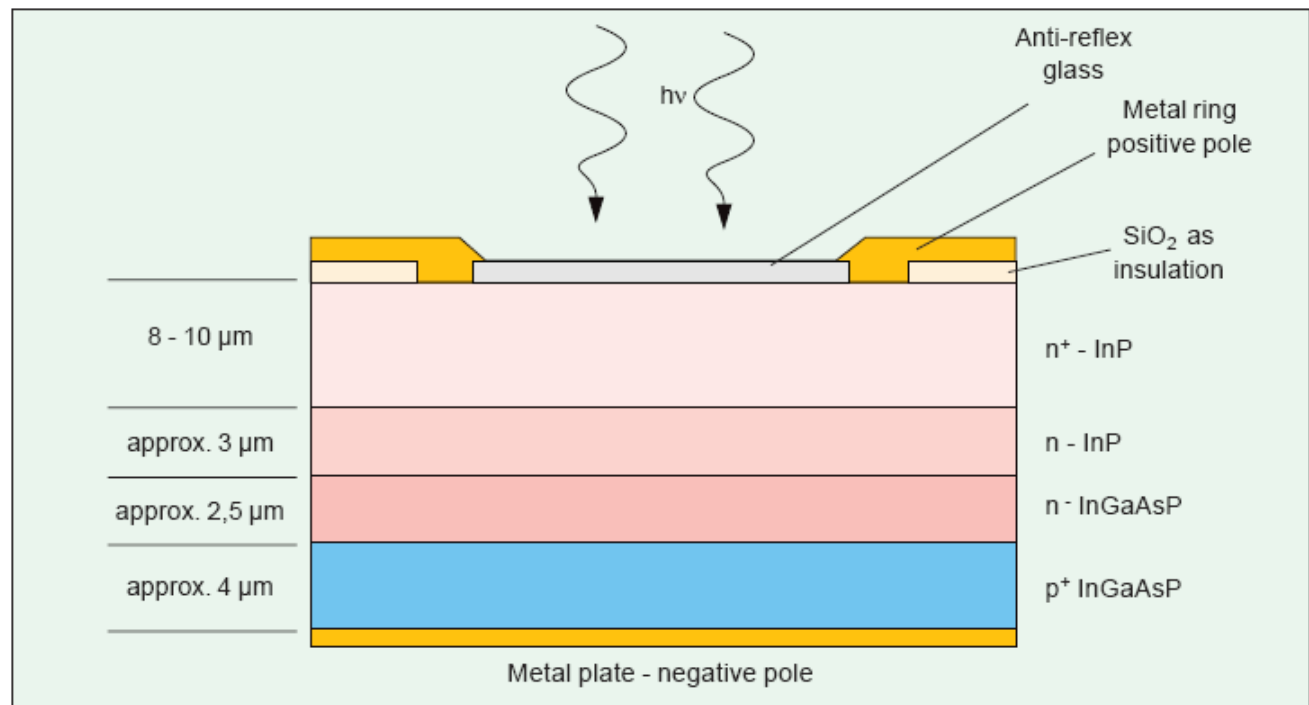
# Structura fotodiodelor Schottky

- ▶ se bazeaza pe jonctiunea metal semiconductor
- ▶ vitezele de lucru sunt mult mai mari, metalul fiind un bun conductor realizeaza evacuarea mult mai rapida a purtatorilor din jonctiune
- ▶ permite utilizarea unor materiale cu eficienta mai mare dar care nu pot fi dopate simultan p si n pentru utilizare in PIN
- ▶ modulatie cu 100GHz posibila



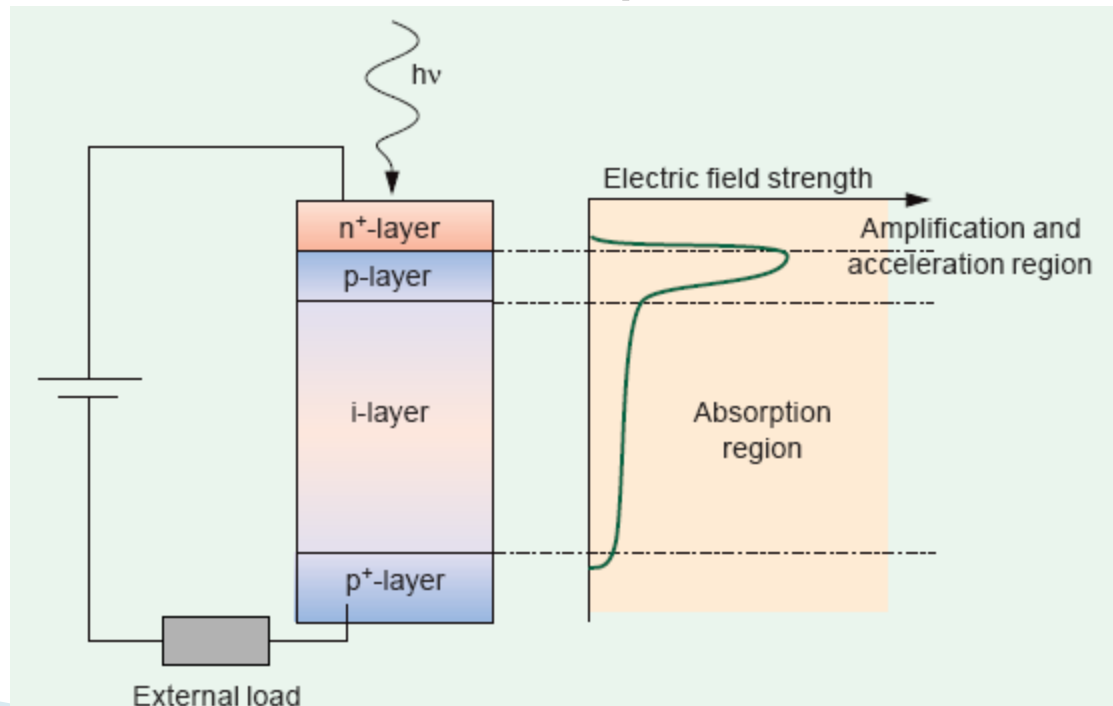
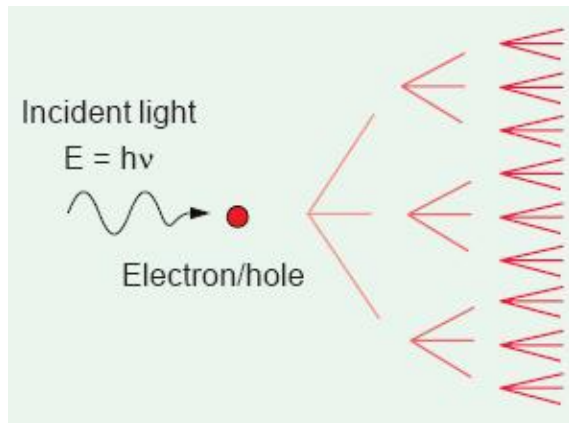
# Fotodioda PIN pentru lungimi de unda crescute (1550nm)

- ▶ se utilizeaza tipic
  - InGaAsP pe substrat InP
  - GaAlAsSb pe substrat GaSb



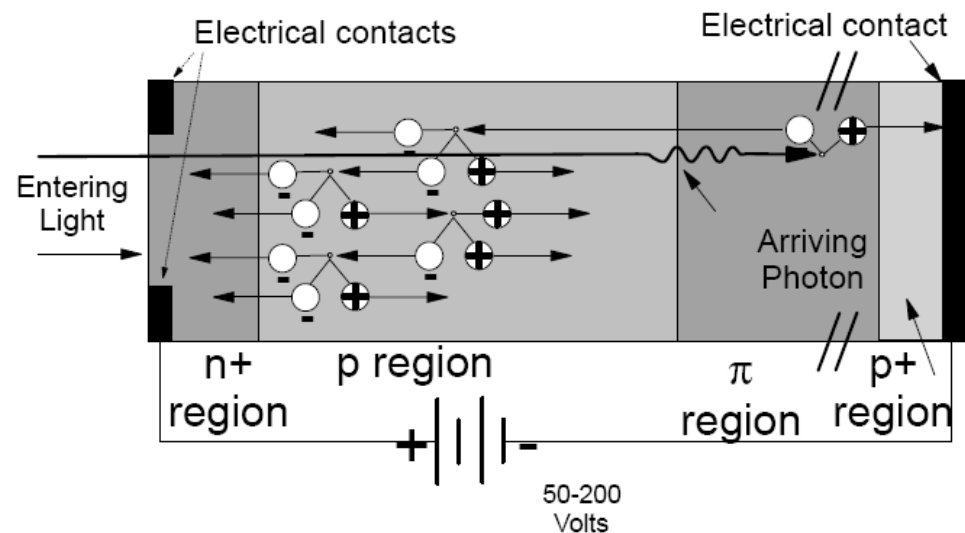
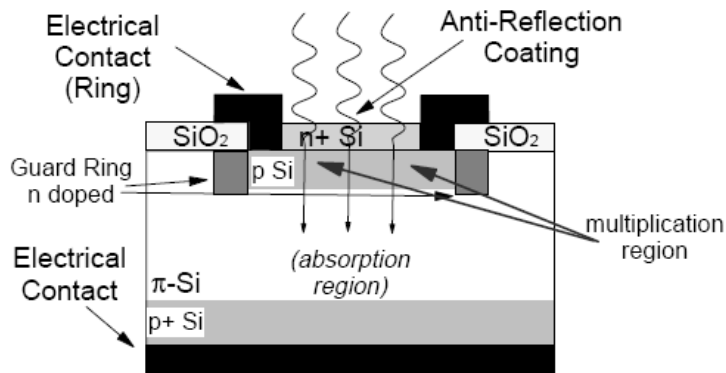
# Fotodioda PIN cu multiplicare in avalansa

- ▶ daca viteza purtatorilor este suficient de mare genereaza noi perechi electron/gol prin ionizare de impact
- ▶ amplificarea are loc in acelasi timp cu detectia



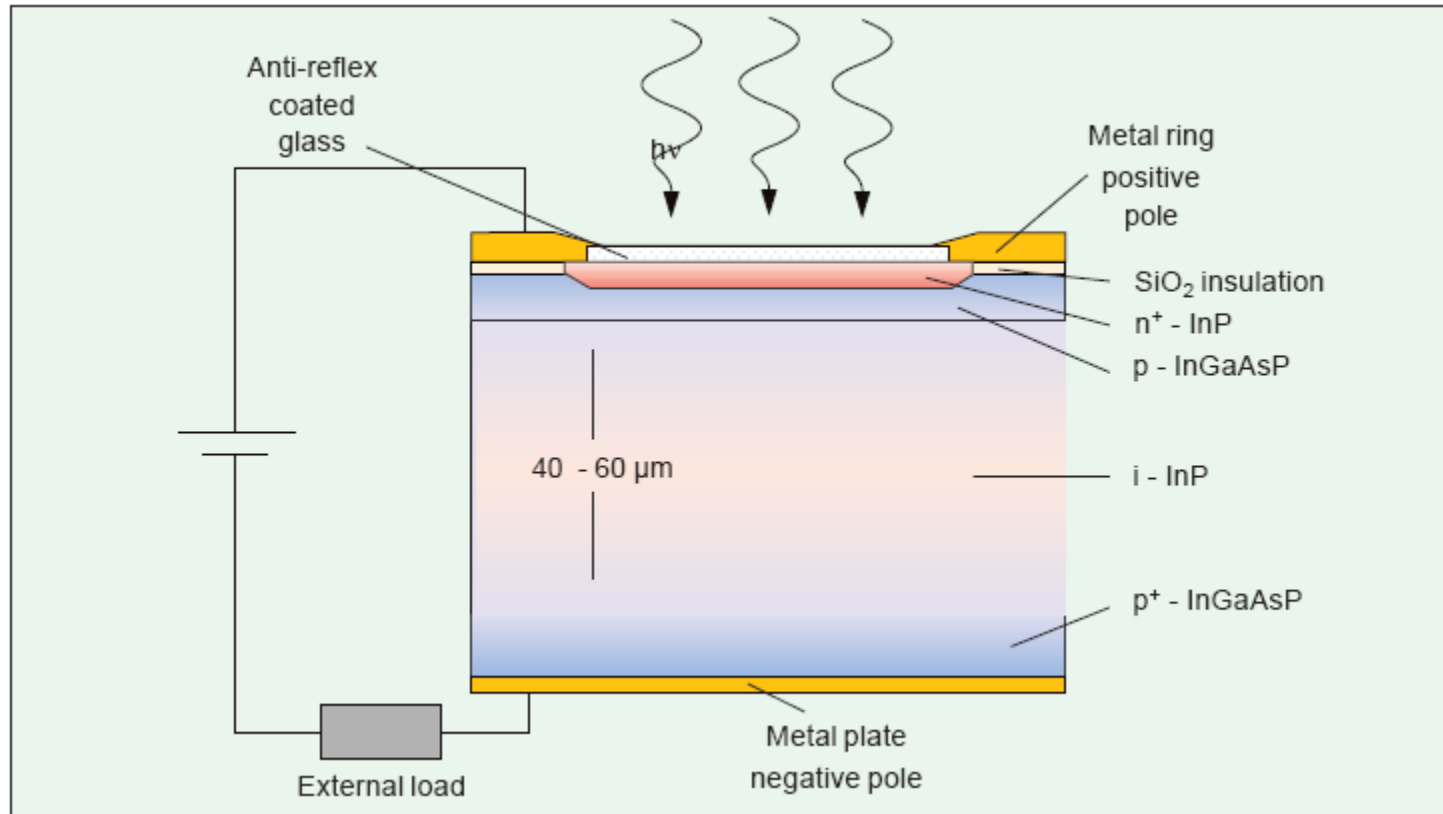
# Functionarea fotodiodei cu multiplicare in avalansa

- ▶ campuri electrice de ordinul minim:  $3 \times 10^5$  V/m, tipic:  $10^6$  V/m sunt necesare
- ▶ aceste campuri sunt generate de tensiuni inverse de polarizare de ordinul 50–300V
- ▶ structura este modificata pentru concentrarea campului in zona de accelerare





# Structura fotodiodei cu multiplicare in avalansa



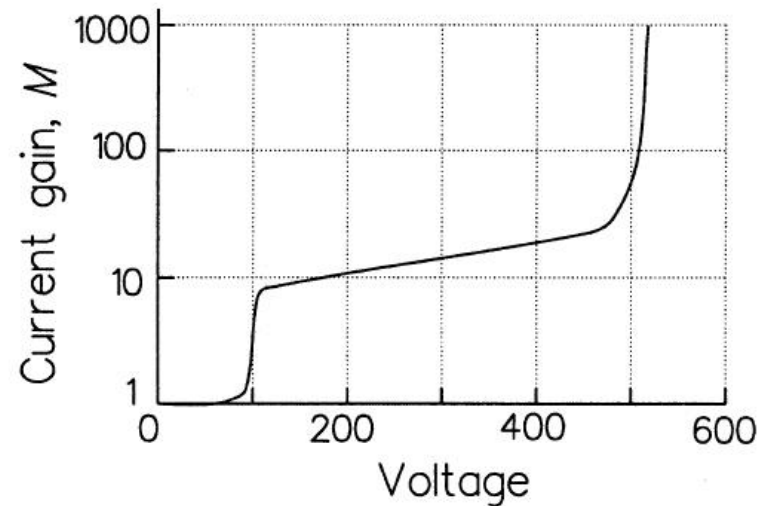
# Caracteristicile fotodiodei cu multiplicare in avalansa

- ▶ factorul de multiplicare caracterizeaza amplificarea fotocurentului generat

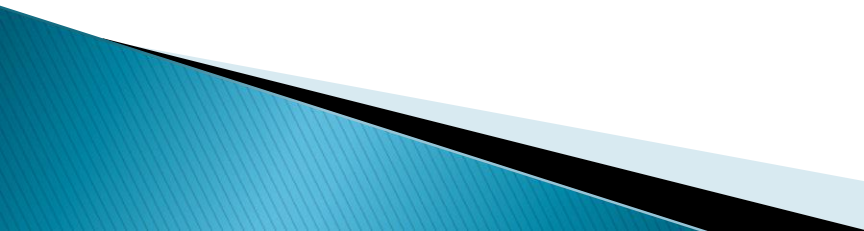
$$M = \frac{I_M}{I}$$

- ▶ Responzivitatea

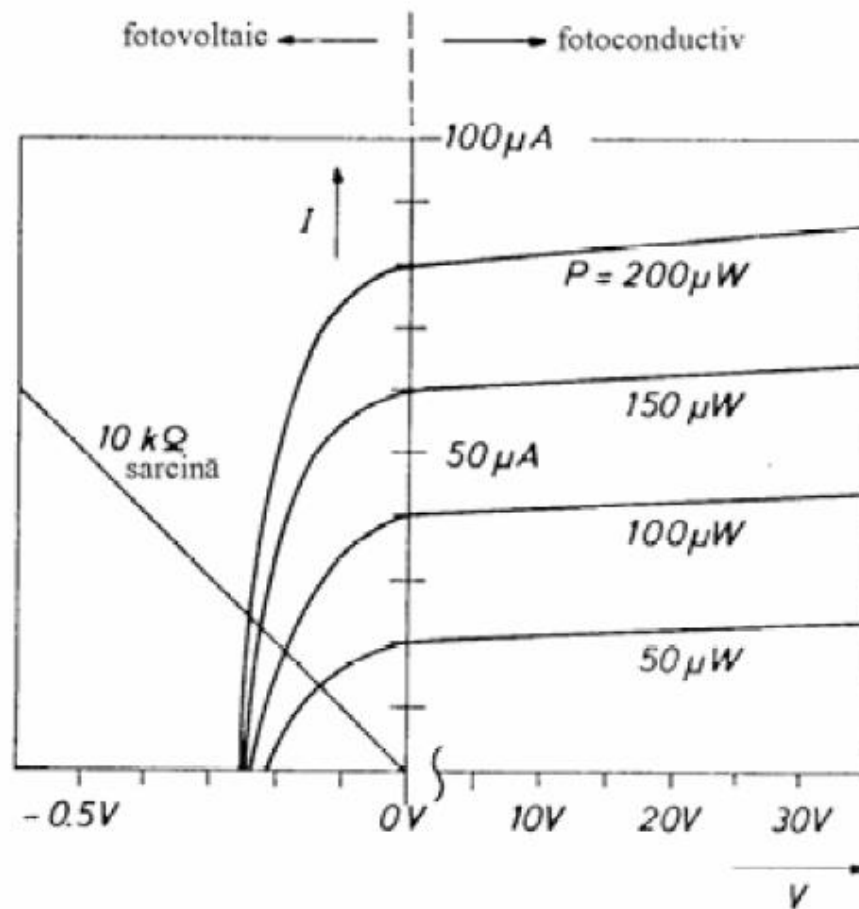
$$R = \frac{I}{P_o} = \frac{\eta \cdot e \cdot \lambda}{hc} \cdot M$$



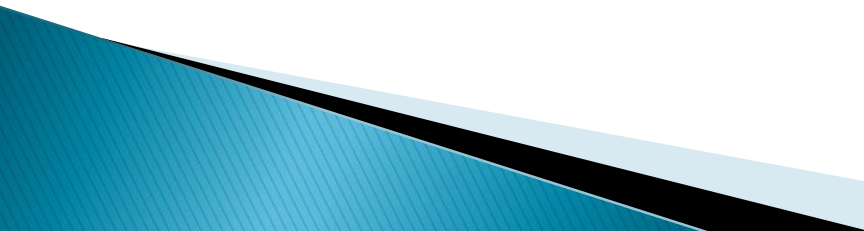
# Dezavantaje

- ▶ tensiuni inverse de polarizare mari cresc complexitatea circuitului
  - ▶ diodele cu multiplicare in avalansa sunt intrinsec mai zgomotoase (curentul de zgomot este amplificat de asemenea)
  - ▶ factorul de multiplicatie are o componenta aleatorie (zgomot suplimentar)
  - ▶ viteza mai redusa (timp de generare al avalansei)
- 

# Caracteristici curent/tensiune Fotodiada

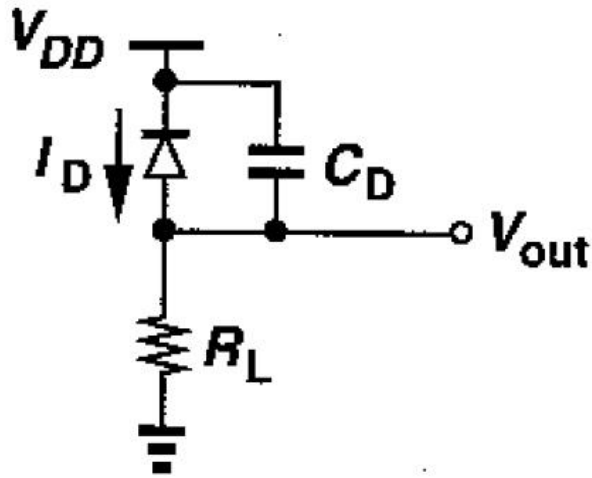


# Amplificatoare transimpedanta

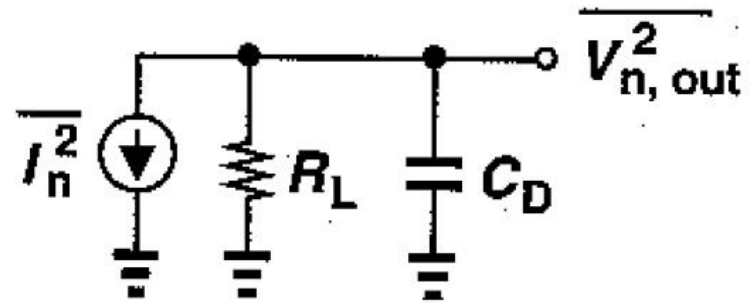
- ▶ Fotodiodele genereaza un curent proportional cu puterea optica receptionata
  - ▶ Primul pas necesar este conversia acestui curent la o tensiune
  - ▶ Amplificatoarele transimpedanta sunt amplificatoarele atacate in curent si care ofera la iesire o tensiune proportionala cu acesta
  - ▶ Amplificarea este masurata in  $\Omega$  ( $k\Omega$ )
- 

# Amplificatoare transimpedanta

- ▶ Cel mai simplu amplificator transimpedanta este un rezistor



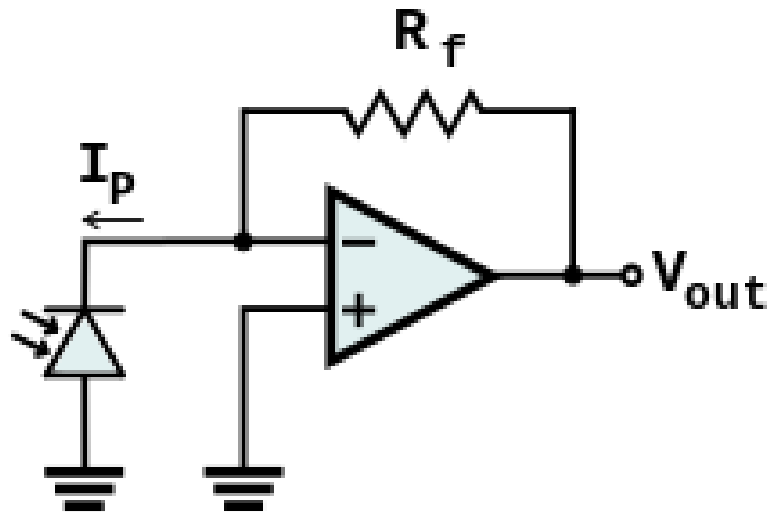
(a)



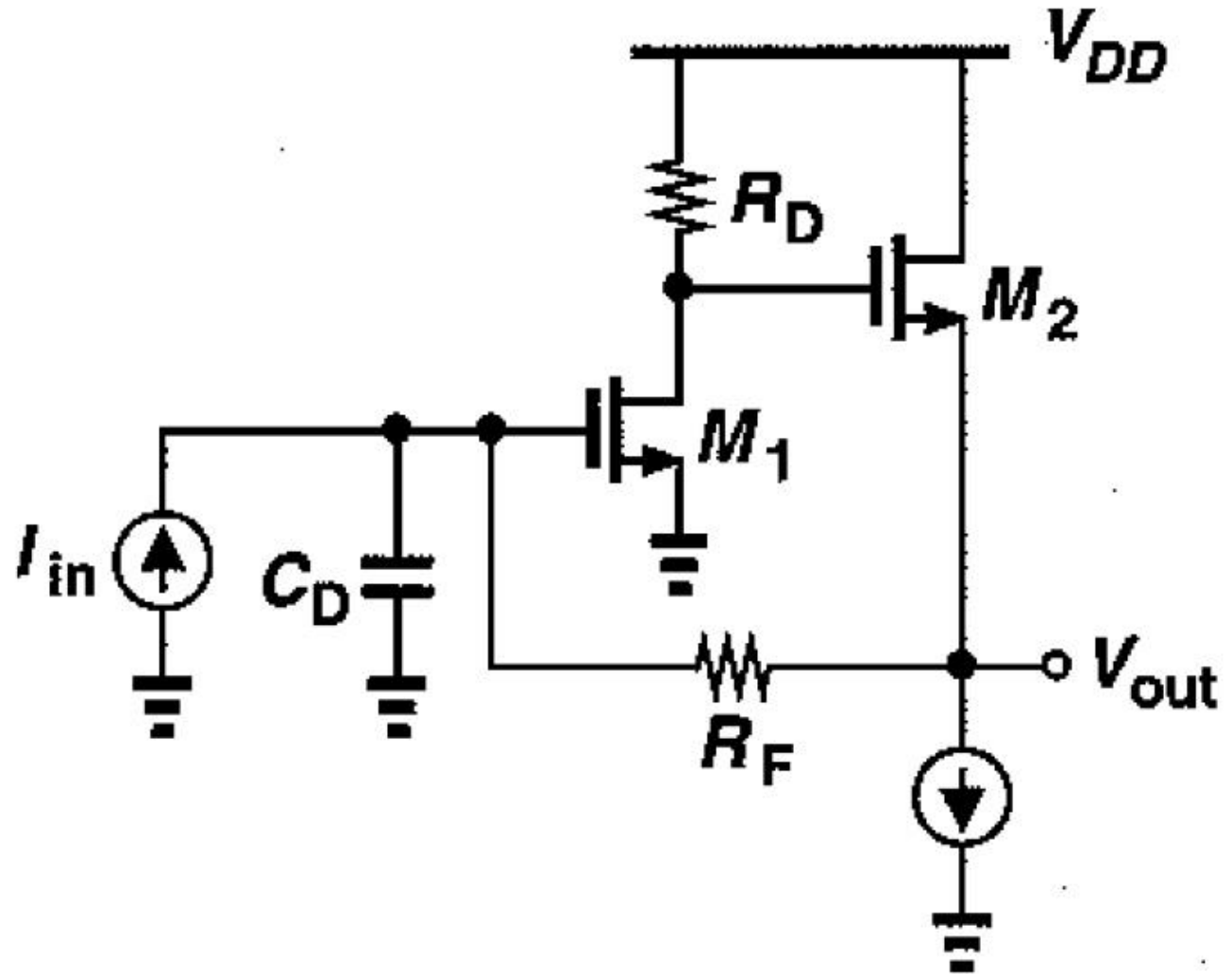
(b)

# Amplificatoare transimpedanta

- ▶ Trebuie realizat un compromis intre
  - zgomot
  - castig
  - viteza
- ▶ De obicei sunt realizate cu reactie



# Amplificatoare transimpedanta





# Zgomotul traductorilor electro-optici

# Zgomotul emitatorilor optici

## ▶ LED

- este considerat o sursa lipsita de zgomot
- nu contamineaza semnalul cu zgomot suplimentar

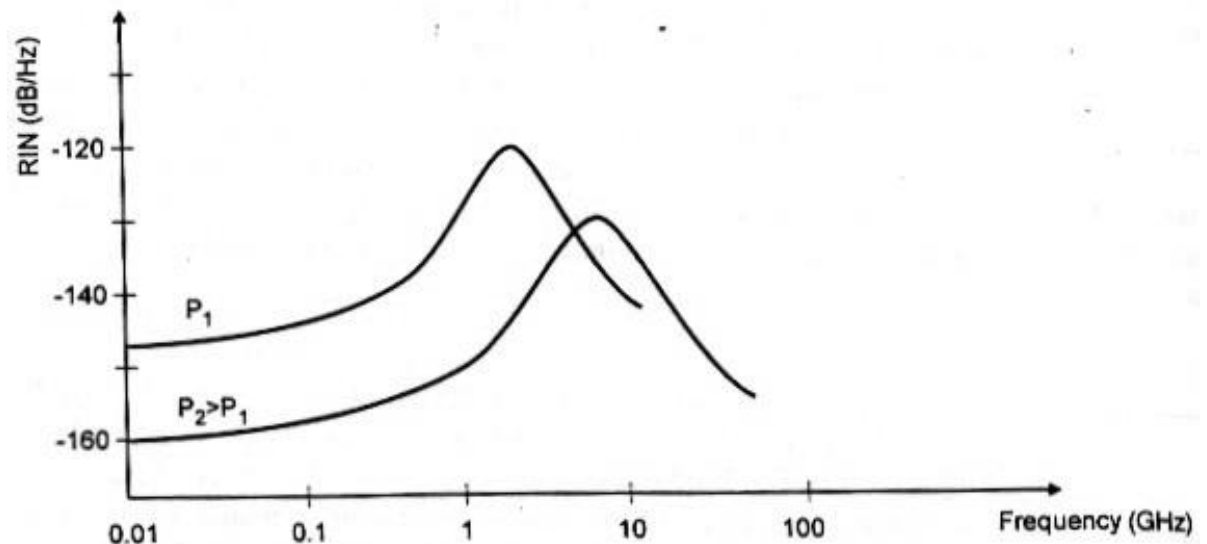
## ▶ Dioda LASER

- fluctuatii de faza, determina o largire a spectrului emis
- fluctuatii de intensitate, determina zgomotul de intensitate introdus de dioda
- RIN – Relative Intensity Noise

$$RIN[1/Hz] = \frac{\langle P_n^2 \rangle}{\langle P^2 \rangle \cdot BW}$$

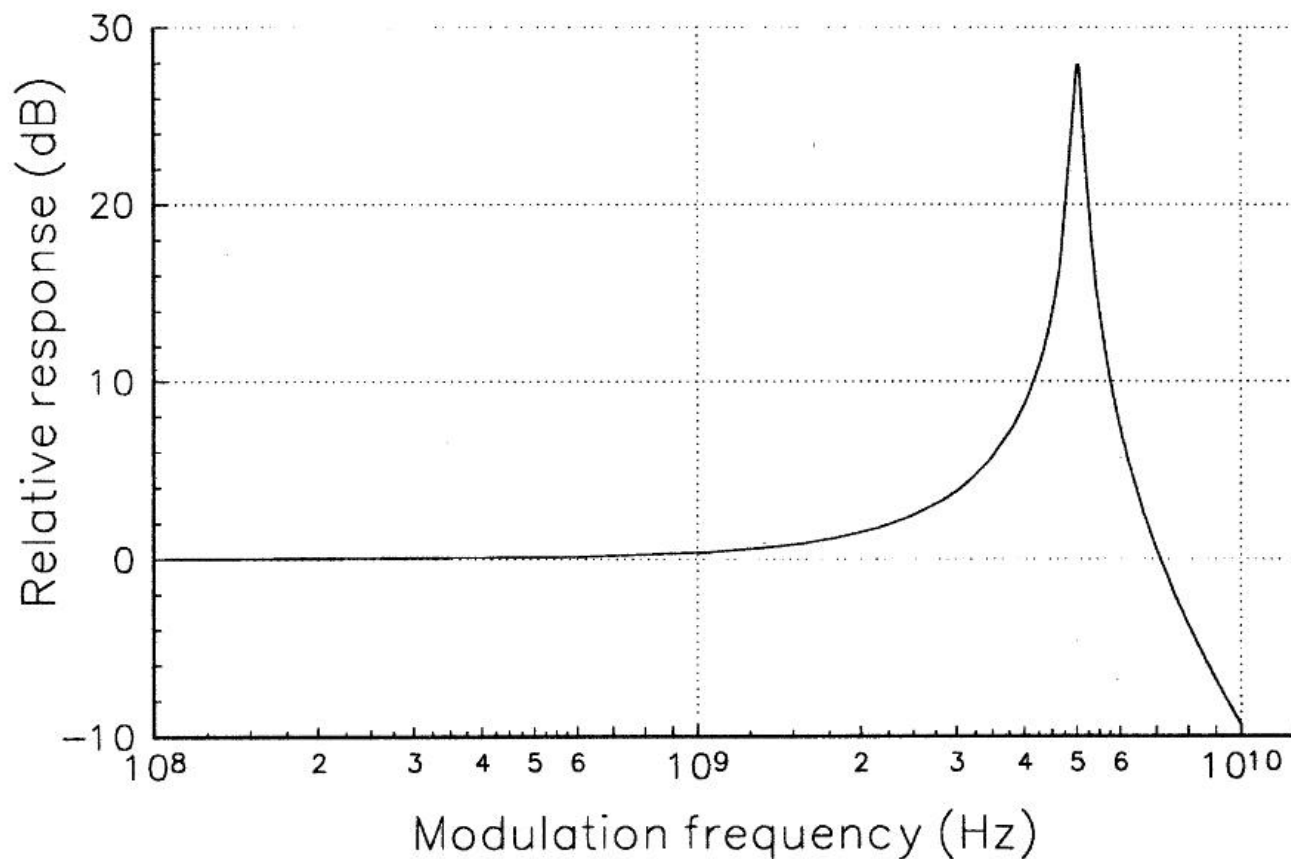
# RIN

- ▶ reprezinta o densitate spectrala de zgomot
  - puterea de zgomot depinde de RIN si de banda semnalului
- ▶ Depinde de puterea semnalului
  - $P^{-3}$  la puteri mici,  $P^{-1}$  la puteri mari



# Raspunsul unei diode laser

- ▶ oscilatii de relaxare - x GHz



# EIN

## ► Equivalent Input Noise

- $R_i$  – rezistenta de intrare in circuitul de modulare a diodei
- Variatiile de putere (zgomot) echivalente unor variatii de curent (zgomot) prin dioda

$$\langle P_n^2 \rangle = r \cdot \langle I_n^2 \rangle$$

$$EIN[W] = R_i \cdot \langle I_n^2 \rangle \quad 1 \text{ Hz banda}$$

$$EIN[W / Hz] = RIN \cdot (I_0 - I_{th})^2 \cdot R_i$$

# Zgomotul fotodiodei

## ▶ NEP

- Noise Equivalent Power
- $r$  – rezonvizitatea diodei

$$NEP[W] = \frac{\int \sqrt{\langle i_n^2 \rangle} df}{r}$$

- $r$  depinde de  $\lambda$ , implica NEP depinde de  $\lambda$
- In cataloage apare de obicei densitatea spectrala

$$NEP[W / \sqrt{Hz}] = \frac{\sqrt{\langle i_n^2 \rangle}}{r} = \frac{NEP}{\sqrt{BW_{PD}}}$$

# Zgomotul fotodiodei

## ▶ NEP

- cea mai mica putere detectabila

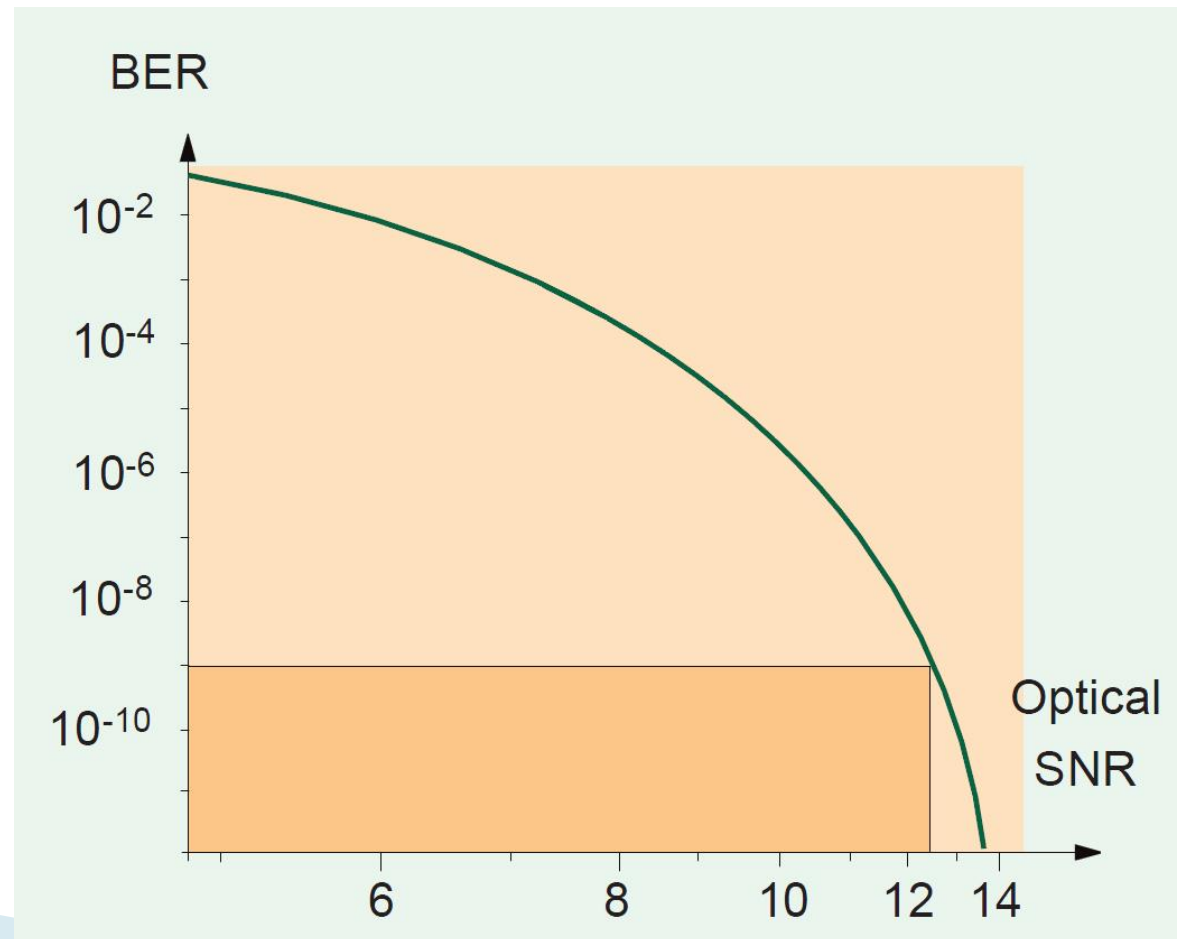
$$\langle i_n^2 \rangle = 2 \cdot e \cdot I \cdot BW_{PD} = 2 \cdot e \cdot (I_S + I_{dark}) \cdot BW_{PD}$$

$$P_{\min} = \frac{\sqrt{\langle i_n^2 \rangle_{\min}}}{r} = \frac{1}{r} \cdot \sqrt{2 \cdot e \cdot I_{dark} \cdot BW_{PD}}$$

$$NEP[W / \sqrt{Hz}] = \frac{1}{r} \cdot \sqrt{2 \cdot e \cdot I_{dark}}$$

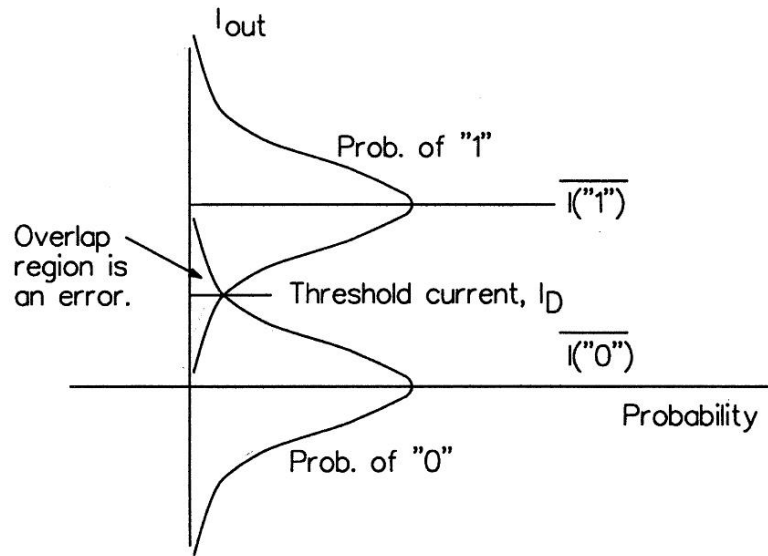
# BER

## ▶ Bit Error Rate

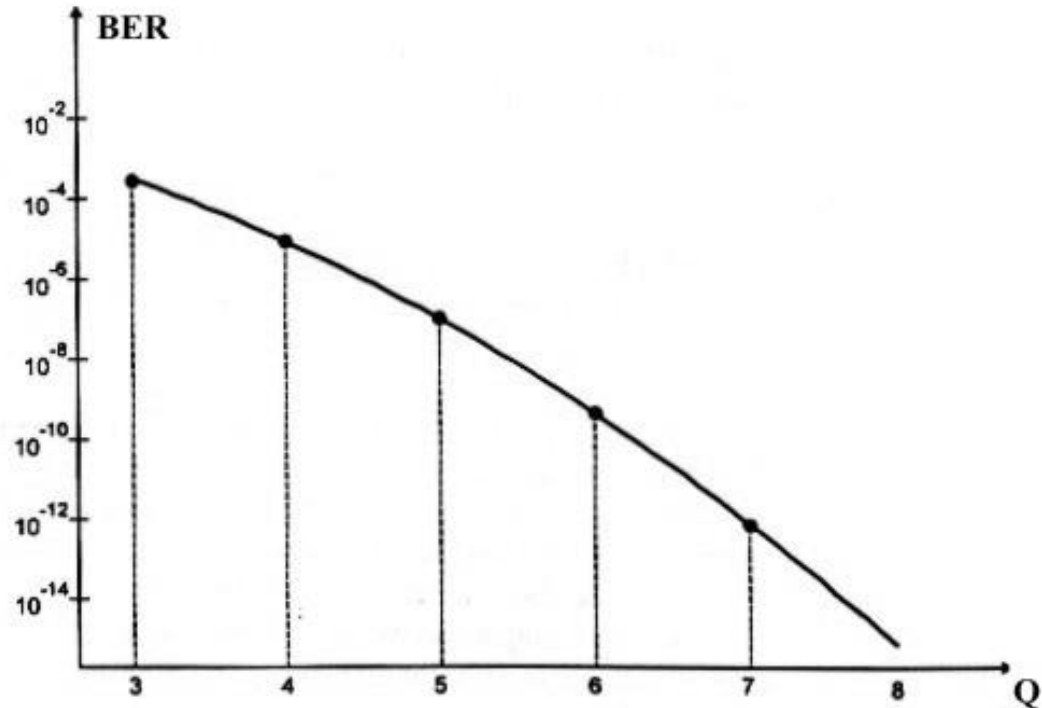




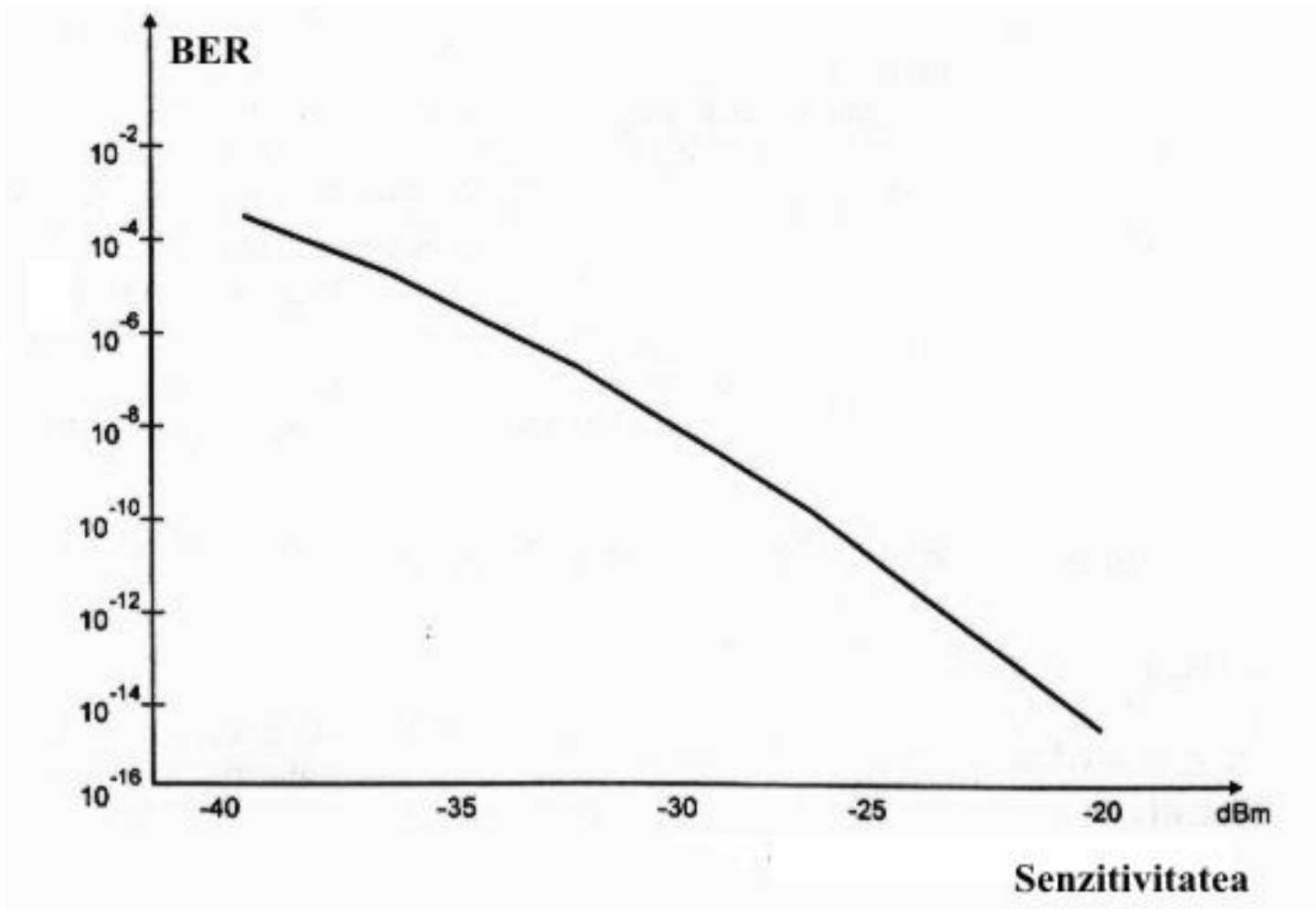
# Probabilitate de eroare



$$Q = \frac{\overline{i(1)} - I_D}{\sigma_1} = \frac{I_D - \overline{i(0)}}{\sigma_0}$$



# Senzitivitatea unei diode



# Contact

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- ▶ [rdamian@etti.tuiasi.ro](mailto:rdamian@etti.tuiasi.ro)